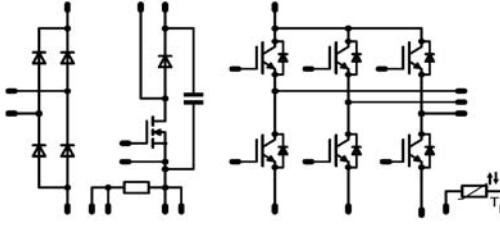


flowPIM0+PFC 2nd		600V/6A
Features	<ul style="list-style-type: none"> Clip in PCB mounting Trench Fieldstop IGBT's for low saturation losses Latest generation superjunction MOSFET for PFC 	flowPIM0+PFC 2nd 
Target Applications	<ul style="list-style-type: none"> Industrial Drives Embedded Drives 	Schematic 
Types	<ul style="list-style-type: none"> 10-F006PPA006SB-M682B 	

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Input Rectifier Diode				
Repetitive peak reverse voltage	V_{RRM}		1600	V
DC forward current	I_{FAV}	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	26 36	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$	200	A
I^2t -value	I^2t	$T_j=150^\circ\text{C}$	200	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{j\max}$ $T_h=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	32 48	W
Maximum Junction Temperature	$T_{j\max}$		150	$^\circ\text{C}$

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
-----------	--------	-----------	-------	------

PFC MOSFET

Drain to source breakdown voltage	V_{DS}		600	V	
DC drain current	I_D	$T_h=T_j\text{max}$ $T_c=80^\circ\text{C}$	10 11	A	
Pulsed drain current	$I_{D\text{pulse}}$	t_p limited by $T_j\text{max}$	59	A	
Avalanche energy, single pulse	E_{AS}	$I_D=3,4\text{A}$ $V_{DD}=50\text{V}$	$T_j=25^\circ\text{C}$	418	mJ
Avalanche energy, repetitive	E_{AR}	$I_D=3,4\text{A}$ $V_{DD}=50\text{V}$	$T_j=25^\circ\text{C}$	0.63	mJ
Avalanche current, repetitive	I_{AR}		$T_j=25^\circ\text{C}$	3,4	A
MOSFET dv/dt ruggedness	dv/dt		50	V/ns	
Power dissipation	P_{tot}	$T_h=T_j\text{max}$ $T_c=80^\circ\text{C}$	47 70	W	
Gate-source peak voltage	V_{GS}		20	V	
Reverse diode dv/dt	dv/dt		15	V/ns	
Maximum Junction Temperature	$T_j\text{max}$		150	°C	

PFC Diode

Peak Repetitive Reverse Voltage	V_{RRM}	$T_j=25^\circ\text{C}$	600	V
DC forward current	I_F	$T_h=T_j\text{max}$ $T_c=80^\circ\text{C}$	12 12	A
Repetitive peak forward current	I_{FRM}	t_p limited by $T_j\text{max}$	18	A
Power dissipation	P_{tot}	$T_h=T_j\text{max}$ $T_c=80^\circ\text{C}$	32 49	W
Maximum Junction Temperature	$T_j\text{max}$		175	°C

PFC Shunt

DC forward current	I_F	$T_c=25^\circ\text{C}$	10	A
Power dissipation per Shunt	P_{tot}	$T_c=25^\circ\text{C}$	5	W

Maximum Ratings

$T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Inverter Transistor				
Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_h=T_j\max$ $T_c=80^\circ\text{C}$	9 13	A
Pulsed collector current	I_{Cpulse}	t_p limited by $T_j\max$	18	A
Turn off safe operating area		$V_{CE} \leq 400\text{V}$, $T_j \leq T_{Op\max}$	18	A
Power dissipation per IGBT	P_{tot}	$T_h=T_j\max$ $T_c=80^\circ\text{C}$	28 43	W
Gate-emitter peak voltage	V_{GE}		20	V
Short circuit ratings	t_{sc} V_{CC}	$T_j \leq 150^\circ\text{C}$ $ V_{GE} =15\text{V}$	6 360	μs V
Maximum Junction Temperature	$T_j\max$		175	°C

Inverter Diode

Peak Repetitive Reverse Voltage	V_{RRM}	$T_j=25^\circ\text{C}$	600	V
DC forward current	I_F	$T_h=T_j\max$ $T_c=80^\circ\text{C}$	13 16	A
Repetitive peak forward current	I_{FRM}	t_p limited by $T_j\max$	12	A
Power dissipation per Diode	P_{tot}	$T_h=T_j\max$ $T_c=80^\circ\text{C}$	21 32	W
Maximum Junction Temperature	$T_j\max$		175	°C

Maximum Ratings

T_j=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
DC link Capacitor				
Max.DC voltage	V _{MAX}	T _c =25°C	500	V
Thermal Properties				
Storage temperature	T _{stg}		-40...+125	°C
Operation temperature under switching condition	T _{op}		-40...+(T _{jmax} - 25)	°C
Insulation Properties				
Insulation voltage	V _{is}	t=2s DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm
Comparative tracking index	CTI		>200	

Characteristic Values

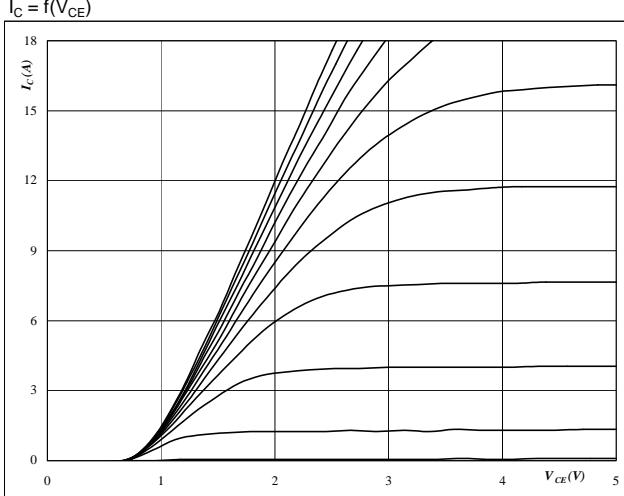
Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] or V_{GS} [V]	V_T [V] or V_{CE} [V] or V_{DS} [V]	I_C [A] or I_F [A] or I_D [A]	T_J	Min	Typ	Max	
Input Rectifier Diode										
Forward voltage	V_F				25	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		1,20 1,17		V
Threshold voltage (for power loss calc. only)	V_{to}				25	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,92 0,81		V
Slope resistance (for power loss calc. only)	r_t				25	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		10,9 14,4		mΩ
Reverse current	I_r			1600		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$			0,05	mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						2,20		K/W
PFC MOSFET										
Static drain to source ON resistance	$R_{DS(on)}$		10		6	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		203 398		mΩ
Gate threshold voltage	$V_{(GS)th}$	$V_{GS}=V_{DS}$			0,00063	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$	2,4	3,0	3,6	V
Gate to Source Leakage Current	I_{GSS}		20	0		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$			100	nA
Zero Gate Voltage Drain Current	I_{DSS}		0	600		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$			1000	nA
Turn On Delay Time	$t_{d(ON)}$	$R_{goff}=4 \Omega$ $R_{gon}=4 \Omega$	10	400	6	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		17 16		
Rise Time	t_r					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		2 2		ns
Turn off delay time	$t_{d(OFF)}$					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		103 113		
Fall time	t_f					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		6 9		
Turn-on energy loss per pulse	E_{on}					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,045 0,091		mWs
Turn-off energy loss per pulse	E_{off}					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,006 0,007		
Total gate charge	Q_{GE}							63		
Gate to source charge	Q_{GS}	0/10	480	9,5	$T_J=25^\circ\text{C}$			7,6		nC
Gate to drain charge	Q_{GD}							32		
Input capacitance	C_{iss}							1400		
Output capacitance	C_{oss}	$f=1\text{MHz}$	0	100	$T_J=25^\circ\text{C}$			85		pF
Gate resistance	R_G							6		
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						1,51		K/W
PFC Diode										
Forward voltage	V_F				6	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		2,83 1,66		V
Reverse leakage current	I_{rm}			600		$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$			50 500	μA
Peak recovery current	I_{RRM}	$R_{gon}=4 \Omega$	10	400	6	$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		29 31		A
Reverse recovery time	t_{rr}					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		9 15		ns
Reverse recovery charge	Q_{rr}					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,12 0,29		μC
Reverse recovered energy	E_{rec}					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		0,013 0,042		mWs
Peak rate of fall of recovery current	$dI(rec)/dt$					$T_J=25^\circ\text{C}$ $T_J=125^\circ\text{C}$		12276 7905		A/μs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						2,95		K/W
PFC Shunt										
R1 value	R							50		mΩ
Temperature coefficient	t_c	20°C to 60°C							30	ppm/K
Internal heat resistance	R_{thi}								10	K/W
Inductance	L								3	nH

Characteristic Values

Parameter	Symbol	Conditions				Value			Unit	
		V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max		
Inverter Transistor										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,00009	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		6	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1,52 1,71		V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	600		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			0,027	mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			300	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$	$R_{goff}=64 \Omega$ $R_{gon}=64 \Omega$	± 15	400	6	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		103 101		ns
Rise time	t_r					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		23 26		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		154 177		
Fall time	t_f					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		96 105		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,19 0,25		mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,21 0,27		
Input capacitance	C_{ies}							368		
Output capacitance	C_{oss}	$f=1\text{MHz}$	0	25		$T_j=25^\circ\text{C}$		28		pF
Reverse transfer capacitance	C_{rss}							11		
Gate charge	Q_{Gate}							42		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						3,38		K/W
Inverter Diode										
Diode forward voltage	V_F				6	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,25	1,62 1,53	1,95	V
Peak reverse recovery current	I_{RRM}	$R_{gon}=64 \Omega$	± 15	400	6	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		3 4		A
Reverse recovery time	t_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		236 341		ns
Reverse recovered charge	Q_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,32 0,60		μC
Peak rate of fall of recovery current	$di(rec)max/dt$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		12 30		$\text{A}/\mu\text{s}$
Reverse recovered energy	E_{rec}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,09 0,17		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um $\lambda = 1 \text{ W/mK}$						4,44		K/W
DC link Capacitor										
C value	C							100		nF
Thermistor										
Rated resistance	R					$T=25^\circ\text{C}$		22000		Ω
Deviation of R100	$\Delta R/R$	$R100=1486 \Omega$				$T=100^\circ\text{C}$	-5		5	%
Power dissipation	P					$T=25^\circ\text{C}$		210		mW
Power dissipation constant						$T=25^\circ\text{C}$		3,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±3%				$T=25^\circ\text{C}$				K
B-value	$B_{(25/100)}$	Tol. ±3%				$T=25^\circ\text{C}$		4000		K
Vincotech NTC Reference									A	

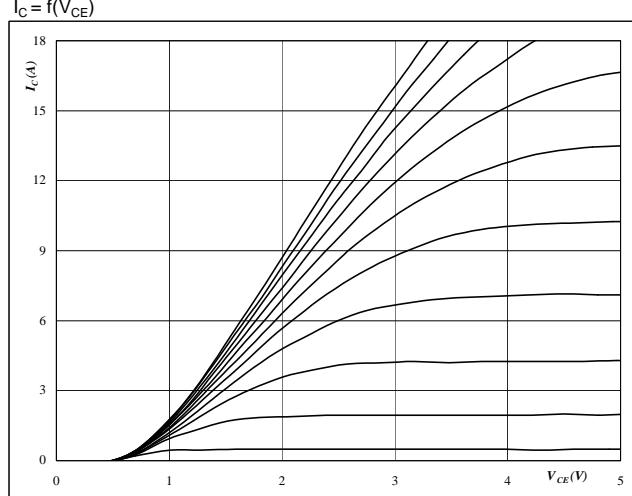
Output Inverter

Figure 1
Typical output characteristics
 $I_C = f(V_{CE})$



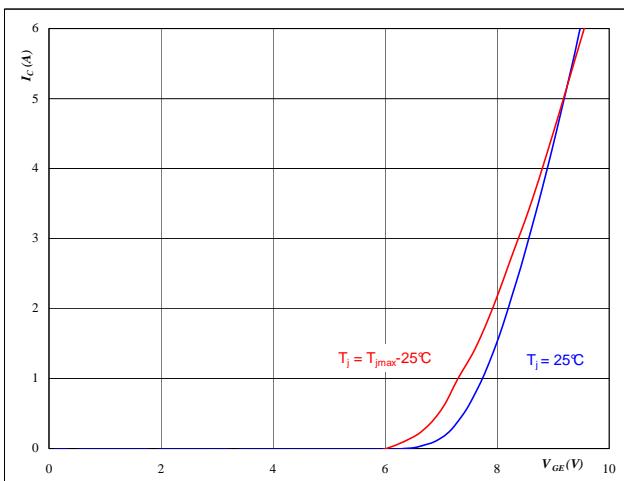
At
 $t_p = 250 \mu s$
 $T_j = 25^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2
Typical output characteristics
 $I_C = f(V_{CE})$



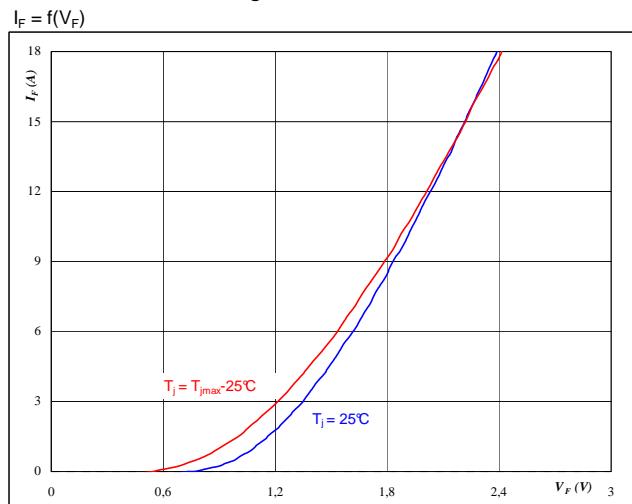
At
 $t_p = 250 \mu s$
 $T_j = 125^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3
Typical transfer characteristics
 $I_C = f(V_{GE})$



At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4
Typical diode forward current as a function of forward voltage
 $I_F = f(V_F)$



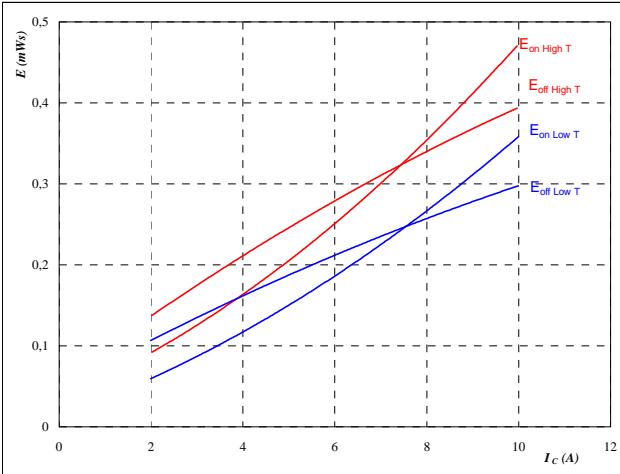
At
 $t_p = 250 \mu s$

Output Inverter

Figure 5

**Typical switching energy losses
as a function of collector current**

$$E = f(I_C)$$



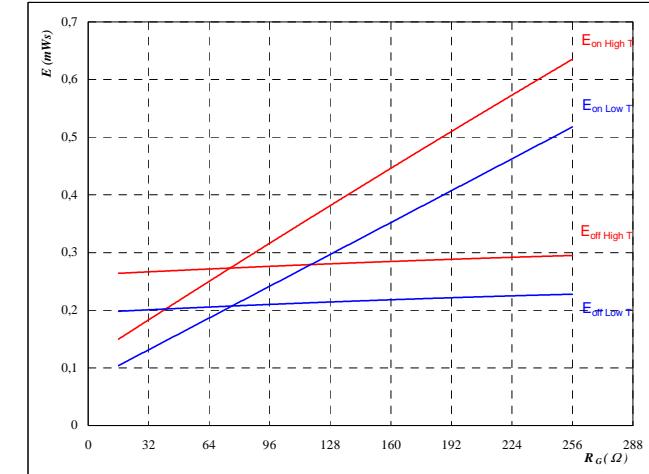
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 64 \quad \Omega \\ R_{goff} &= 64 \quad \Omega \end{aligned}$$

Figure 6

**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$



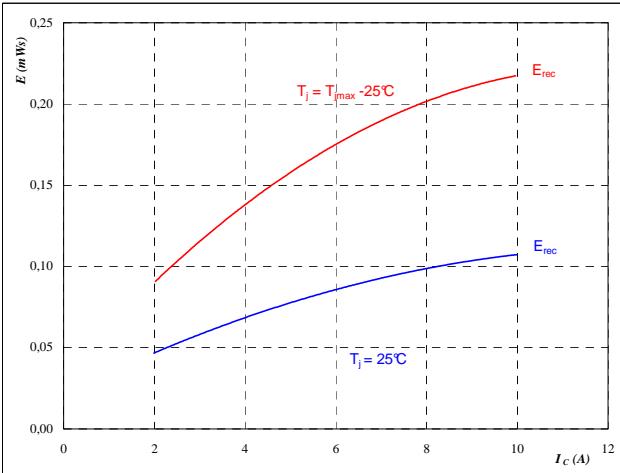
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 6 \quad \text{A} \end{aligned}$$

Figure 7

**Typical reverse recovery energy loss
as a function of collector current**

$$E_{rec} = f(I_C)$$



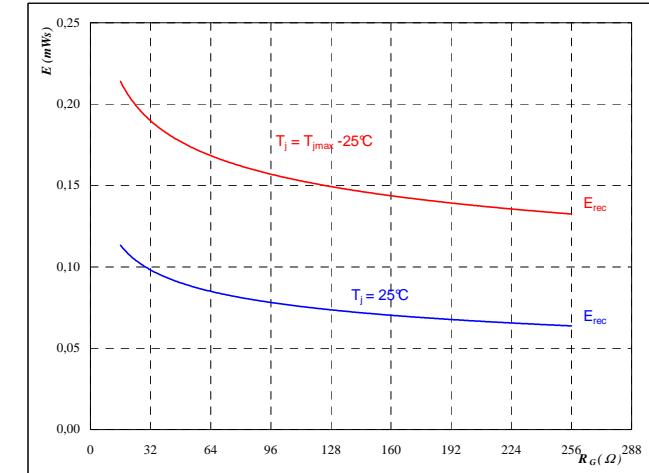
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 64 \quad \Omega \end{aligned}$$

Figure 8

**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



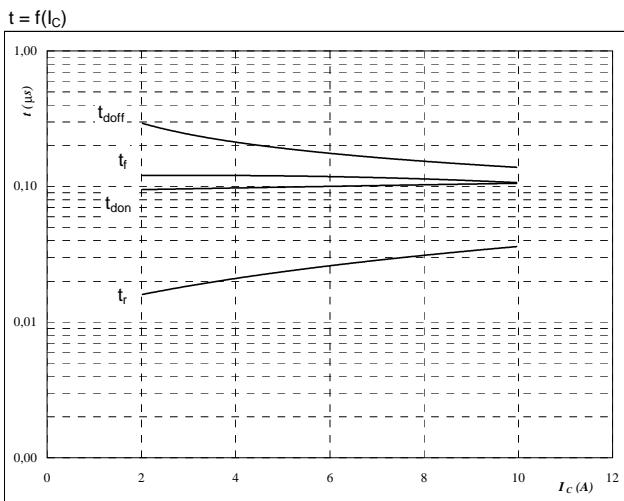
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ I_C &= 6 \quad \text{A} \end{aligned}$$

Output Inverter

Figure 9

Typical switching times as a function of collector current
 $t = f(I_C)$

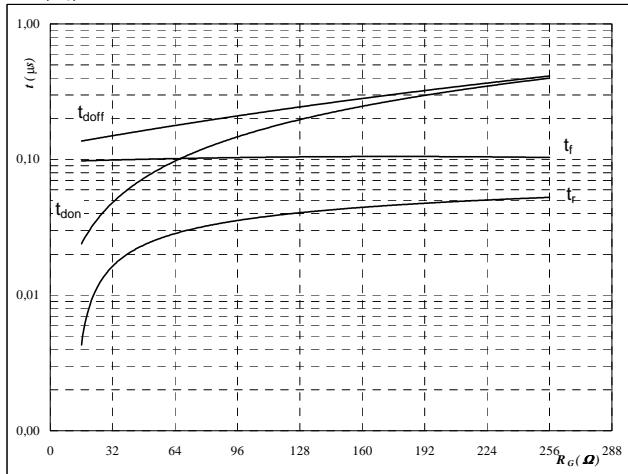


With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	400	V
$V_{GE} =$	± 15	V
$R_{gon} =$	64	Ω
$R_{goff} =$	64	Ω

Figure 10

Typical switching times as a function of gate resistor
 $t = f(R_G)$

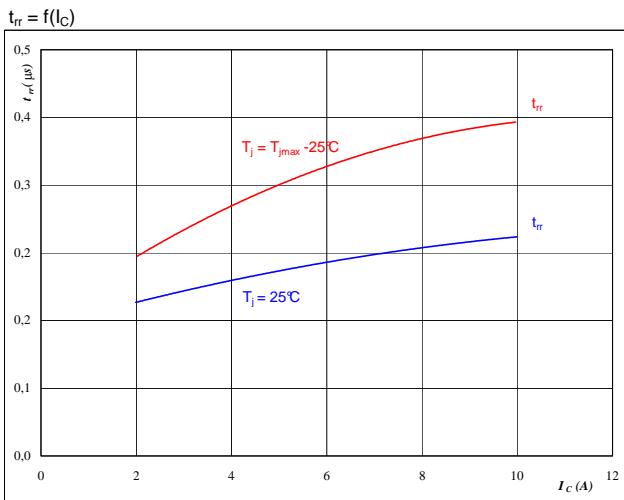


With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	400	V
$V_{GE} =$	± 15	V
$I_C =$	6	A
$R_{goff} =$	64	Ω

Figure 11

Typical reverse recovery time as a function of collector current
 $t_{rr} = f(I_C)$

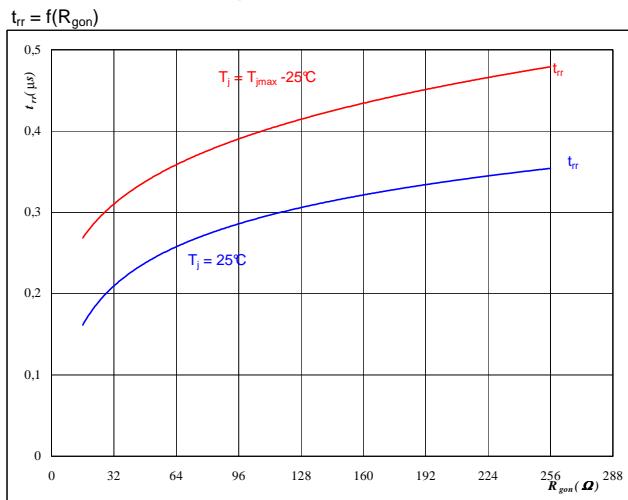


At

$T_j =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	± 15	V
$R_{gon} =$	64	Ω

Figure 12

Typical reverse recovery time as a function of IGBT turn on gate resistor
 $t_{rr} = f(R_{gon})$



At

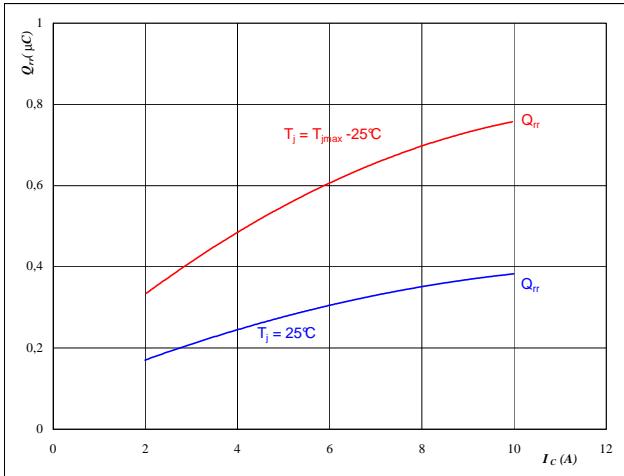
$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	6	A
$V_{GE} =$	± 15	V

Output Inverter

Figure 13

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$

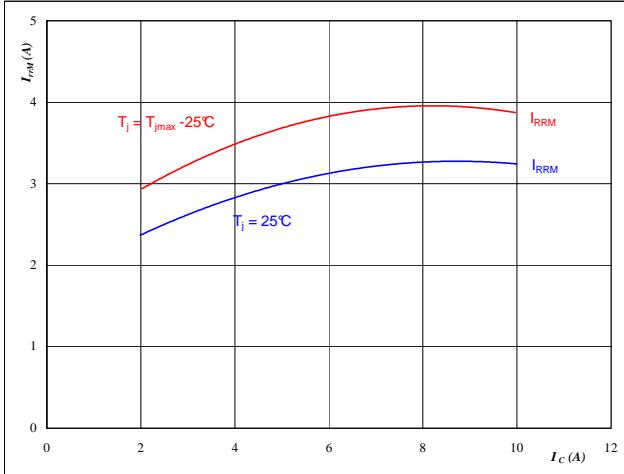

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 64 \quad \Omega \end{aligned}$$

Figure 15

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$

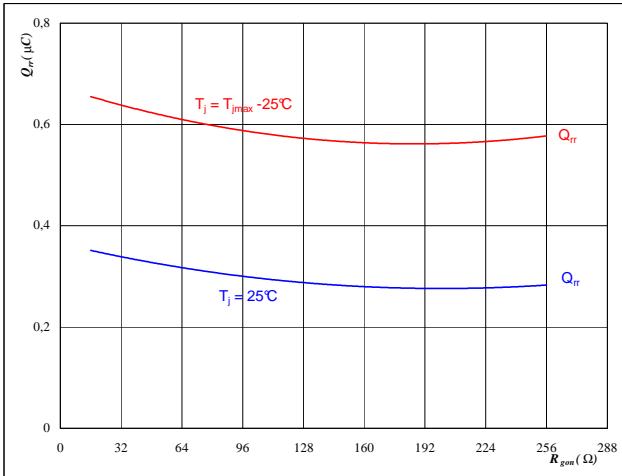

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= \pm 15 \quad \text{V} \\ R_{gon} &= 64 \quad \Omega \end{aligned}$$

Figure 14

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

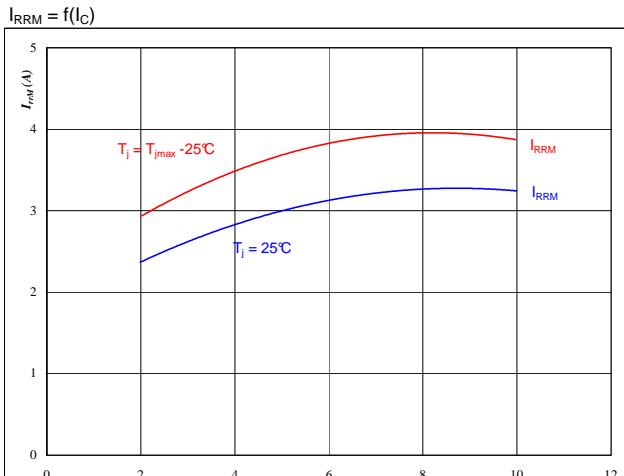

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_R &= 400 \quad \text{V} \\ I_F &= 6 \quad \text{A} \\ V_{GE} &= \pm 15 \quad \text{V} \end{aligned}$$

Figure 15

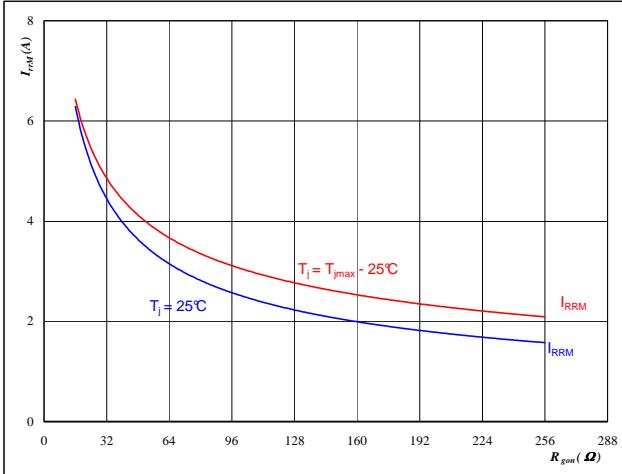
Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(R_{gon})$$


Figure 16

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$

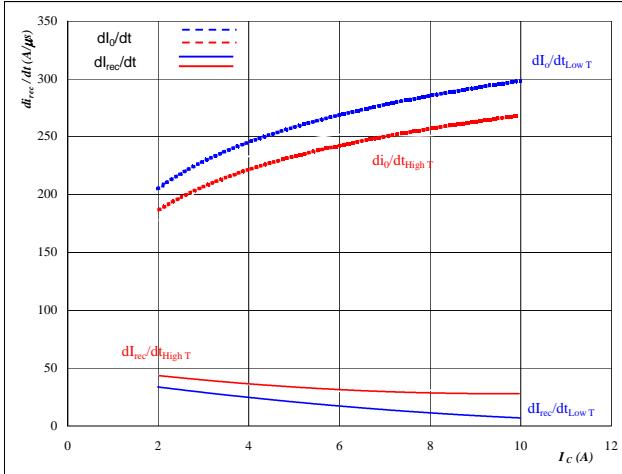

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_R &= 400 \quad \text{V} \\ I_F &= 6 \quad \text{A} \\ V_{GE} &= \pm 15 \quad \text{V} \end{aligned}$$

Output Inverter

Figure 17

Typical rate of fall of forward
and reverse recovery current as a
function of collector current
 $dI_0/dt, dI_{rec}/dt = f(I_C)$

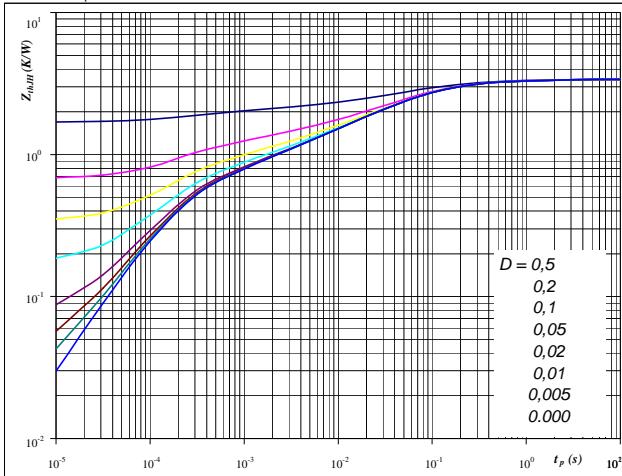

At

$T_j =$	25/125	°C
$V_{CE} =$	400	V
$V_{GE} =$	± 15	V
$R_{gon} =$	64	Ω

Figure 19

IGBT transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

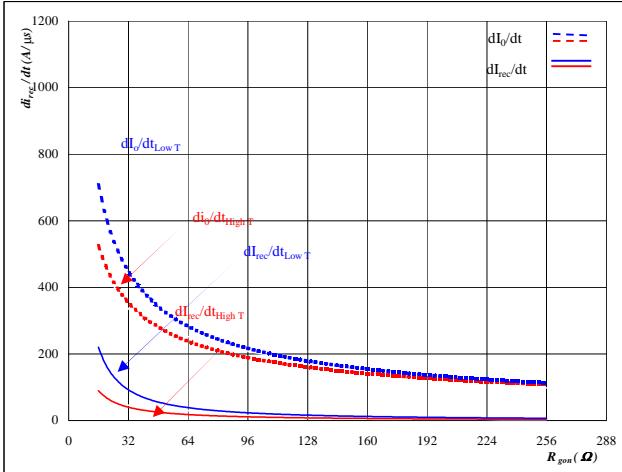
$D =$	t_p / T
$R_{thJH} =$	3,38 K/W

IGBT thermal model values

Thermal grease		Phase change interface	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,16	1,710	0,13	1,387
0,70	0,168	0,56	0,136
1,11	0,044	0,90	0,036
0,55	0,008	0,45	0,007
0,34	0,001	0,27	0,001
0,53	0,000	0,43	0,000

Figure 18

Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor
 $dI_0/dt, dI_{rec}/dt = f(R_{gon})$

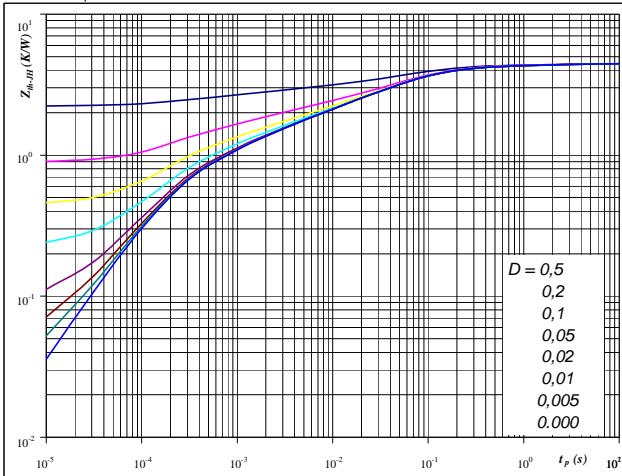

At

$T_j =$	25/125	°C
$V_R =$	400	V
$I_F =$	6	A
$V_{GE} =$	± 15	V

Figure 20

FWD transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

$D =$	t_p / T
$R_{thJH} =$	4,44 K/W

FWD thermal model values

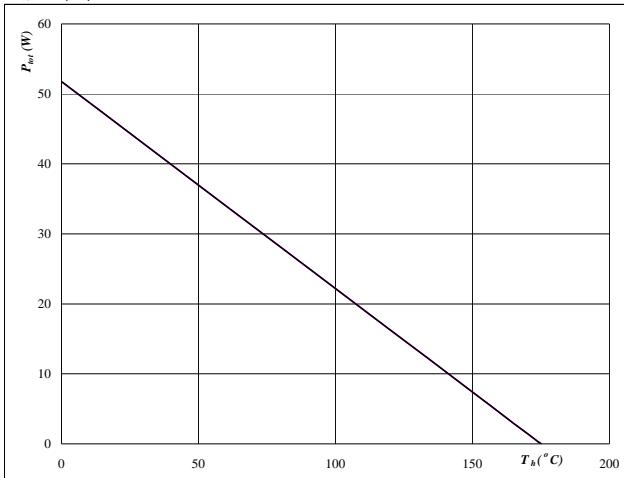
Thermal grease		Phase change interface	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,20	1,973	0,16	1,600
0,90	0,162	0,73	0,131
1,46	0,039	1,18	0,032
0,65	0,007	0,53	0,005
0,56	0,001	0,46	0,001
0,67	0,000	0,54	0,000

Output Inverter

Figure 21

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

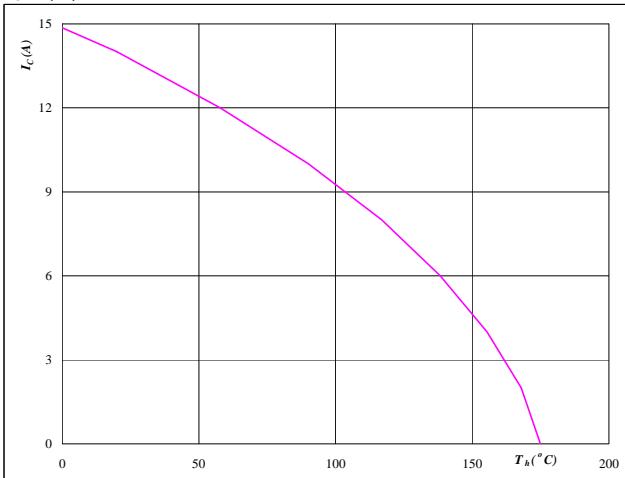

At

$$T_j = 175 \quad ^\circ\text{C}$$

Output inverter IGBT
Figure 22

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$


At

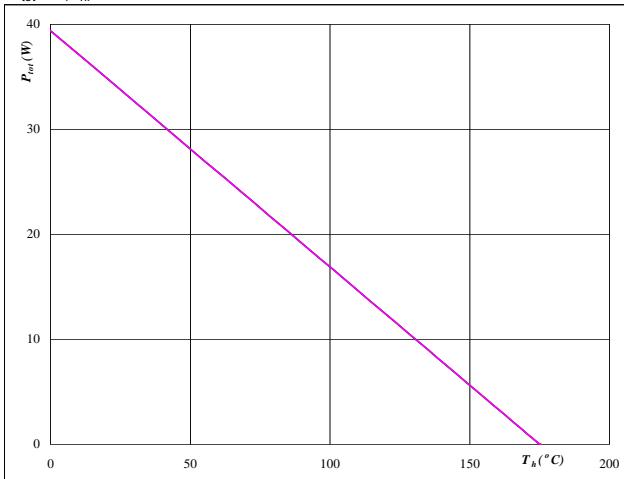
$$T_j = 175 \quad ^\circ\text{C}$$

$$V_{GE} = 15 \quad \text{V}$$

Figure 23
Output inverter FWD

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

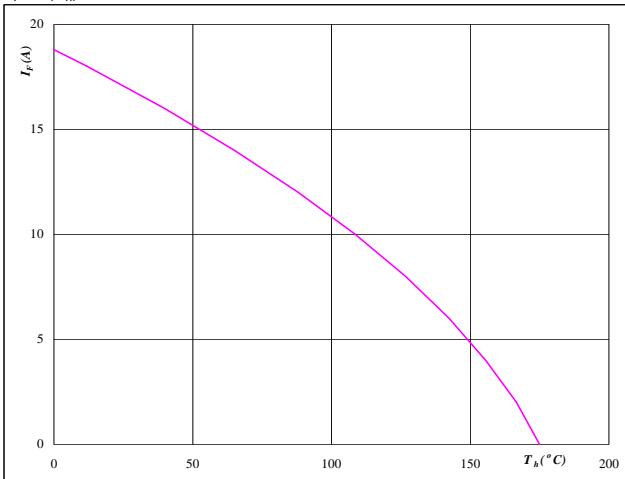

At

$$T_j = 175 \quad ^\circ\text{C}$$

Figure 24
Output inverter FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$


At

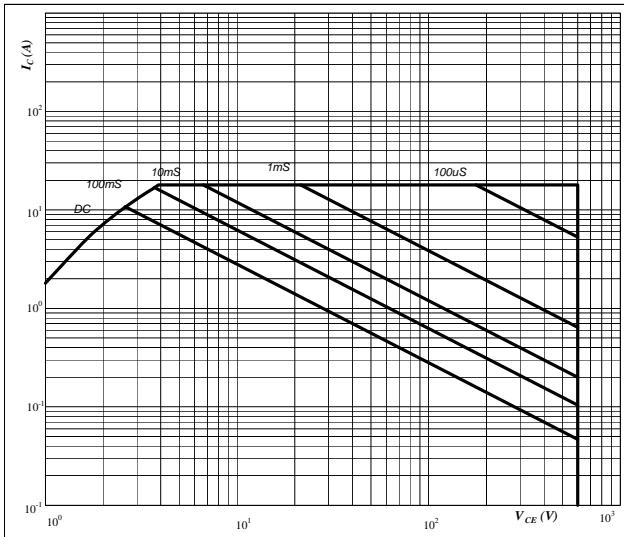
$$T_j = 175 \quad ^\circ\text{C}$$

Output Inverter

Figure 25

Safe operating area as a function
of collector-emitter voltage

$$I_C = f(V_{CE})$$


At

D = single pulse

T_h = 80 °C

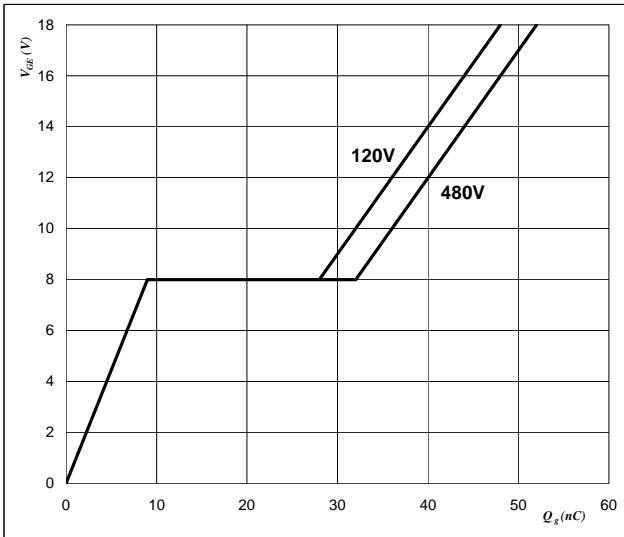
V_{GE} = ±15 V

T_j = T_{jmax} °C

Output inverter IGBT
Figure 26

Gate voltage vs Gate charge

$$V_{GE} = f(Q_{GE})$$

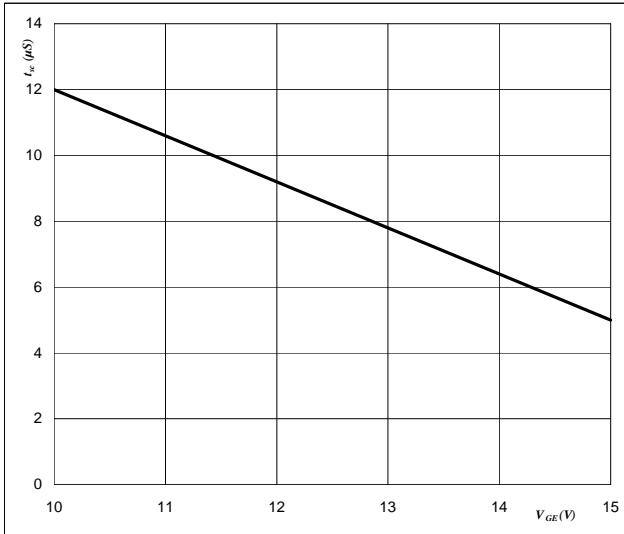

At

I_C = 6 A

Figure 27
Output inverter IGBT

Short circuit withstand time as a function of
gate-emitter voltage

$$t_{sc} = f(V_{GE})$$


At

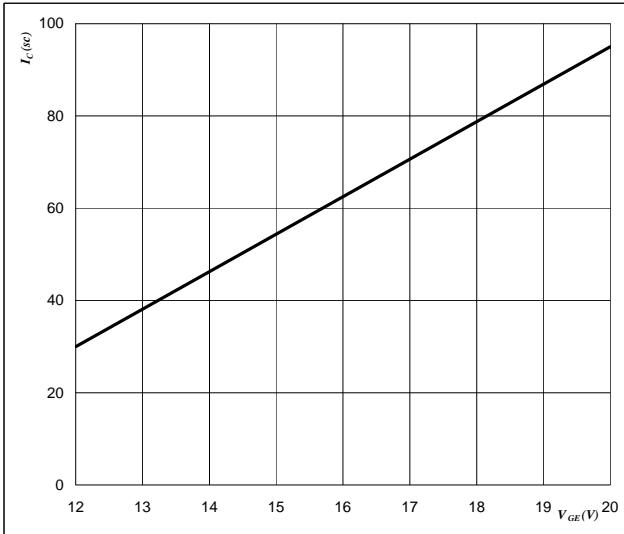
V_{CE} = 600 V

T_j ≤ 175 °C

Figure 28
Output inverter IGBT

Typical short circuit collector current as a function of
gate-emitter voltage

$$V_{GE} = f(Q_{GE})$$


At

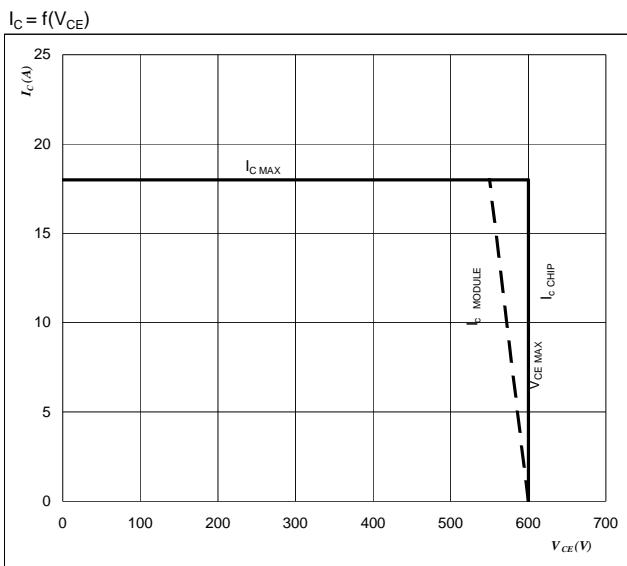
V_{CE} ≤ 600 V

T_j = 175 °C

Output Inverter

Figure 29
Reverse bias safe operating area

IGBT



At

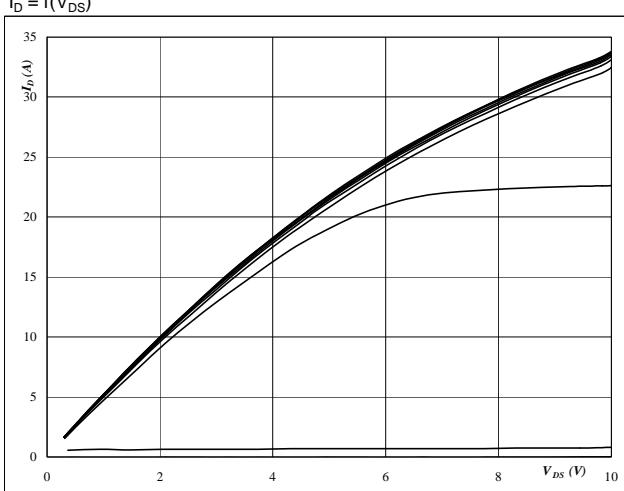
$$T_j = T_{j\max} - 25 \quad ^\circ\text{C}$$

$$U_{ccminus} = U_{ccplus}$$

Switching mode : 3phase SPWM

PFC

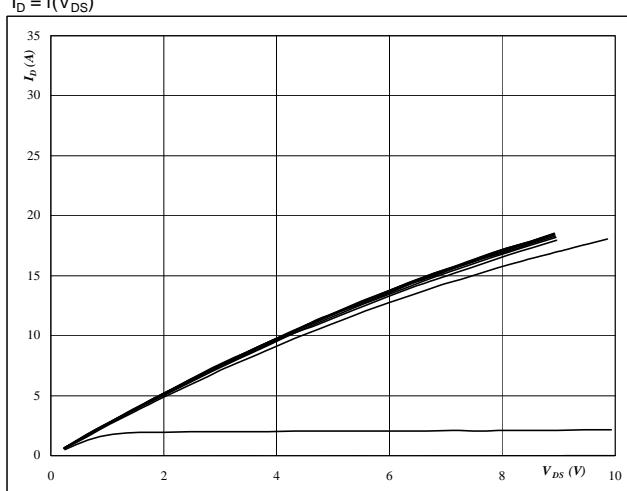
Figure 1
Typical output characteristics
 $I_D = f(V_{DS})$



At
 $t_p = 250 \mu s$
 $T_j = 25^\circ C$
 V_{GS} from 0 V to 20 V in steps of 2 V

PFC MOSFET

Figure 2
Typical output characteristics
 $I_D = f(V_{DS})$

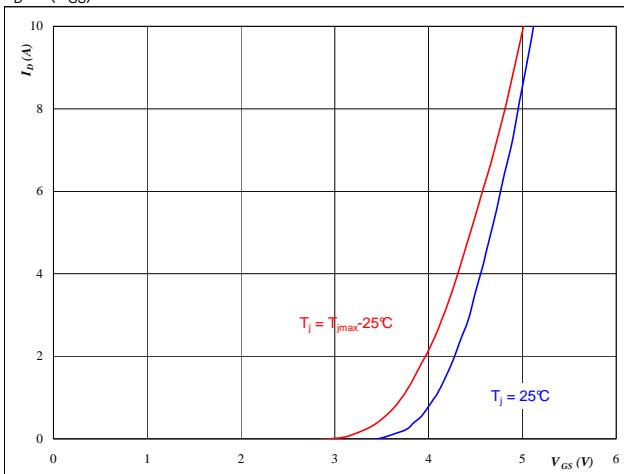


At
 $t_p = 250 \mu s$
 $T_j = 125^\circ C$
 V_{GS} from 0 V to 20 V in steps of 2 V

Figure 3
Typical transfer characteristics

PFC MOSFET

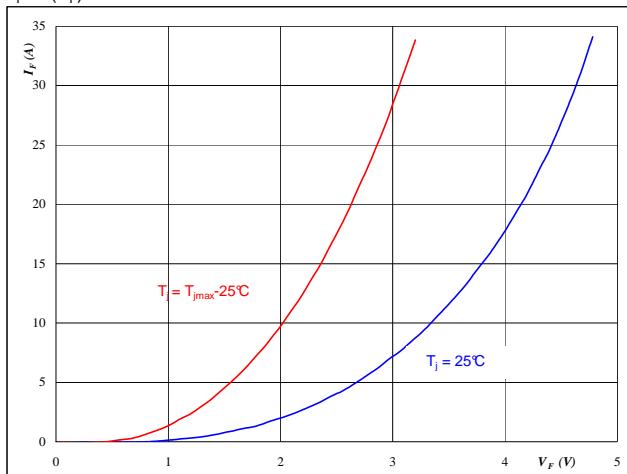
$I_D = f(V_{GS})$



At
 $t_p = 250 \mu s$
 $V_{DS} = 10 V$

Figure 4
Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

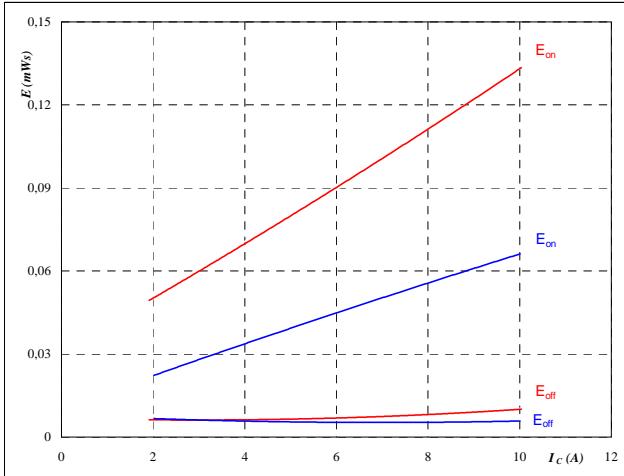


At
 $t_p = 250 \mu s$

PFC

Figure 5
**Typical switching energy losses
as a function of collector current**

$$E = f(I_D)$$



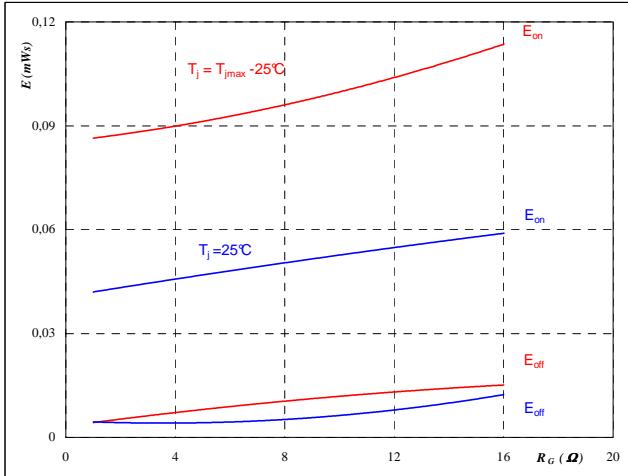
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{DS} &= 400 \quad \text{V} \\ V_{GS} &= 10 \quad \text{V} \\ R_{gon} &= 4 \quad \Omega \\ R_{goff} &= 4 \quad \Omega \end{aligned}$$

PFC MOSFET

Figure 6
**Typical switching energy losses
as a function of gate resistor**

$$E = f(R_G)$$

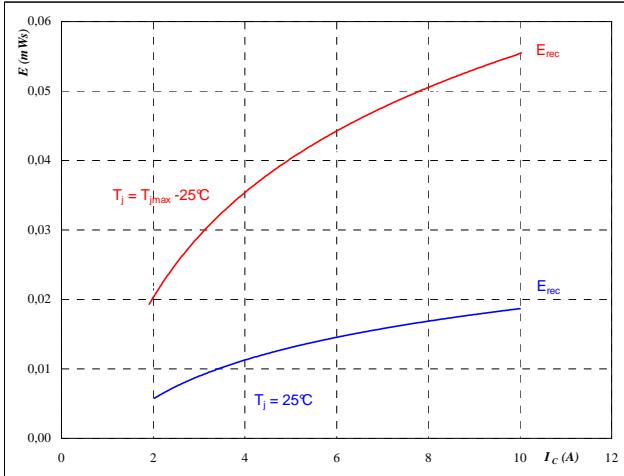


With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{DS} &= 400 \quad \text{V} \\ V_{GS} &= 10 \quad \text{V} \\ I_D &= 6 \quad \text{A} \end{aligned}$$

Figure 7
**Typical reverse recovery energy loss
as a function of collector (drain) current**

$$E_{rec} = f(I_c)$$



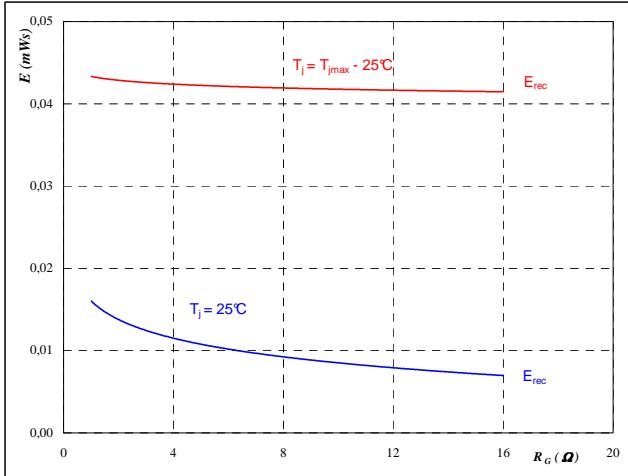
With an inductive load at

$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{DS} &= 400 \quad \text{V} \\ V_{GS} &= 10 \quad \text{V} \\ R_{gon} &= 4 \quad \Omega \\ R_{goff} &= 4 \quad \Omega \end{aligned}$$

PFC MOSFET

Figure 8
**Typical reverse recovery energy loss
as a function of gate resistor**

$$E_{rec} = f(R_G)$$



With an inductive load at

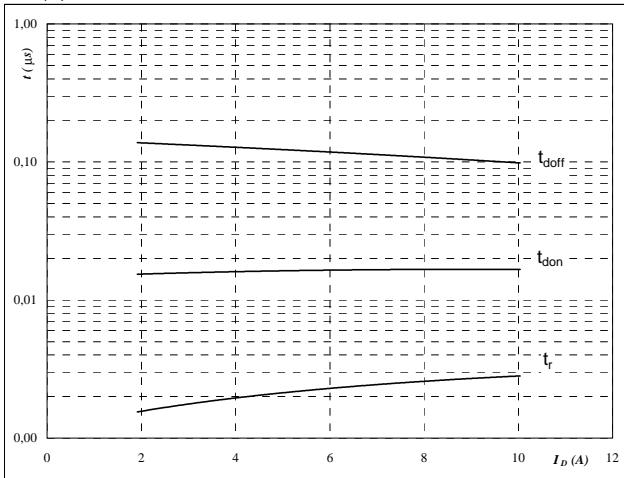
$$\begin{aligned} T_j &= 25/125 \quad ^\circ\text{C} \\ V_{DS} &= 400 \quad \text{V} \\ V_{GS} &= 10 \quad \text{V} \\ I_D &= 6 \quad \text{A} \end{aligned}$$

PFC

Figure 9

Typical switching times as a function of collector current

$$t = f(I_D)$$



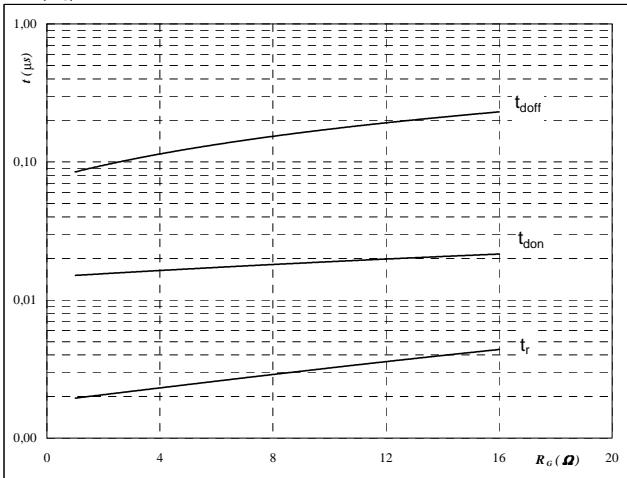
With an inductive load at

T _j =	125	°C
V _{DS} =	400	V
V _{GS} =	10	V
R _{gon} =	4	Ω
R _{goff} =	4	Ω

PFC MOSFET
Figure 10

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



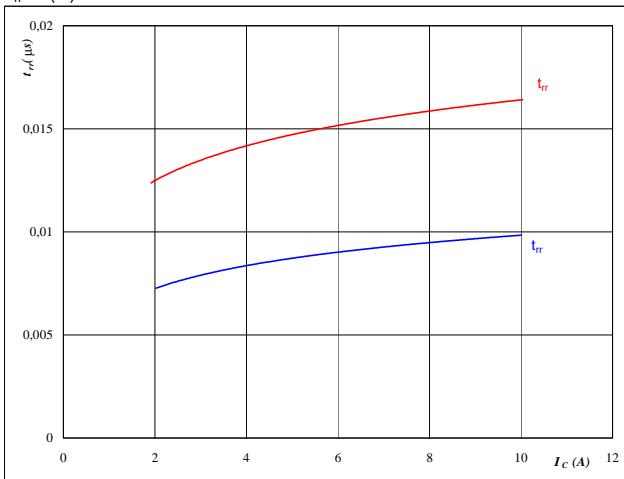
With an inductive load at

T _j =	125	°C
V _{DS} =	400	V
V _{GS} =	10	V
I _C =	6	A

Figure 11
PFC FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



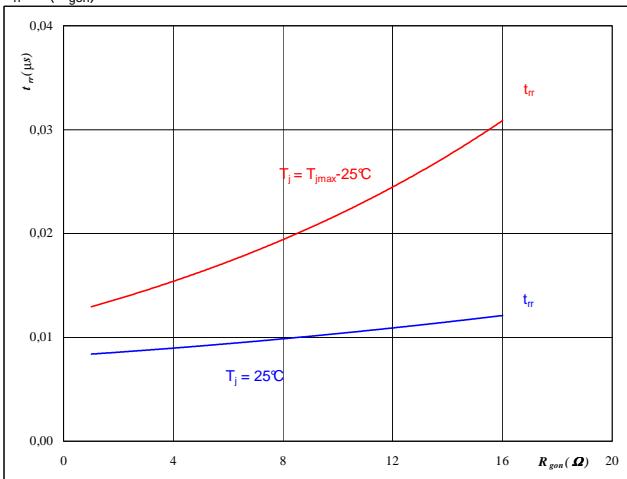
At

T _j =	25/125	°C
V _{CE} =	400	V
V _{GE} =	10	V
R _{gon} =	4,01	Ω

Figure 12
PFC FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

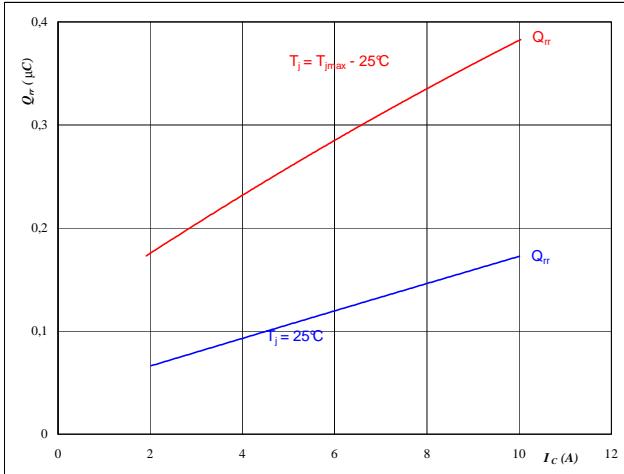
T _j =	25/125	°C
V _R =	400	V
I _F =	6	A
V _{GS} =	10	V

PFC

Figure 13

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$

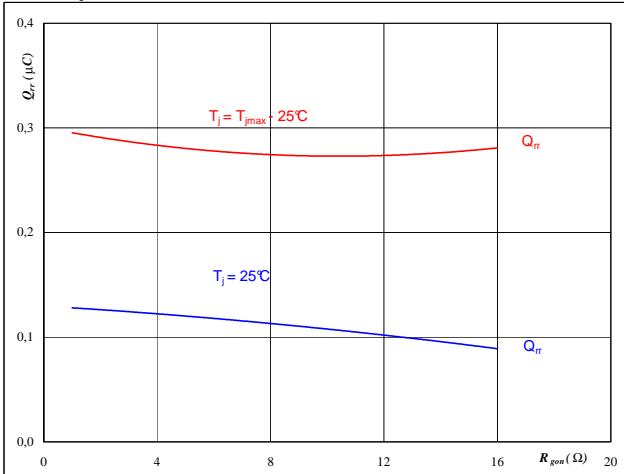

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= 10 \quad \text{V} \\ R_{gon} &= 4 \quad \Omega \end{aligned}$$

PFC FWD
Figure 14

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

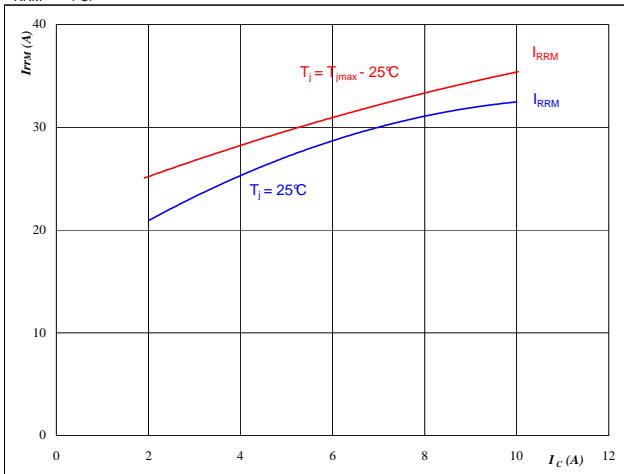

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_R &= 400 \quad \text{V} \\ I_F &= 6 \quad \text{A} \\ V_{GS} &= 10 \quad \text{V} \end{aligned}$$

Figure 15

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$

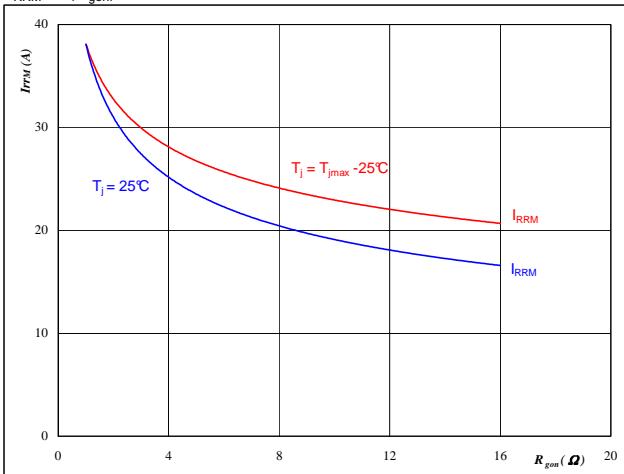

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_{CE} &= 400 \quad \text{V} \\ V_{GE} &= 10 \quad \text{V} \\ R_{gon} &= 4 \quad \Omega \end{aligned}$$

PFC FWD
Figure 16

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$

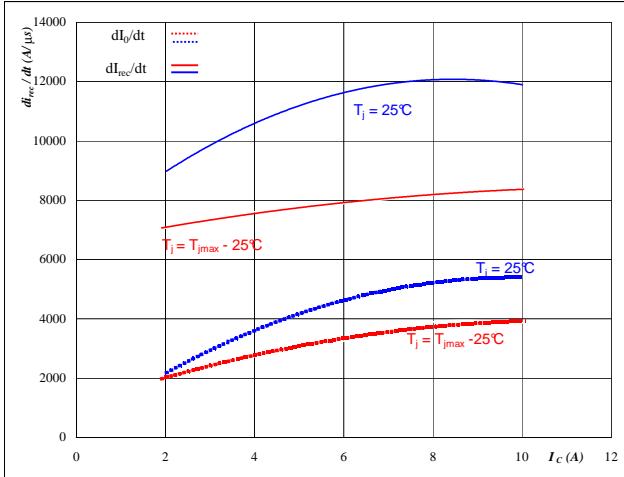

At

$$\begin{aligned} T_j &= 25/125 \quad {}^\circ\text{C} \\ V_R &= 400 \quad \text{V} \\ I_F &= 6 \quad \text{A} \\ V_{GS} &= 10 \quad \text{V} \end{aligned}$$

PFC

Figure 17

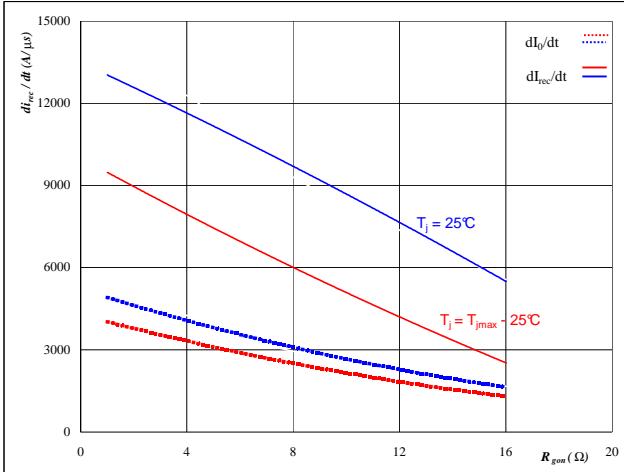
Typical rate of fall of forward
and reverse recovery current as a
function of collector current
 $dI_0/dt, dI_{rec}/dt = f(I_C)$


At

$T_j = 25/125 \quad ^\circ C$
 $V_{CE} = 400 \quad V$
 $V_{GE} = 10 \quad V$
 $R_{gon} = 4 \quad \Omega$

PFC FWD
Figure 18

Typical rate of fall of forward
and reverse recovery current as a
function of IGBT turn on gate resistor
 $dI_0/dt, dI_{rec}/dt = f(R_{gon})$

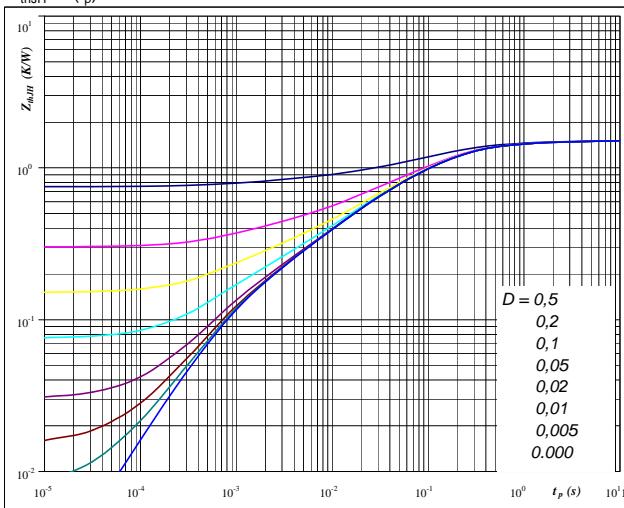

At

$T_j = 25/125 \quad ^\circ C$
 $V_R = 400 \quad V$
 $I_F = 6 \quad A$
 $V_{GS} = 10 \quad V$

Figure 19
PFC MOSFET

IGBT/MOSFET transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

$D = t_p / T$
 $R_{thJH} = 1,51 \quad K/W$ $R_{thJH} = 1,22 \quad K/W$

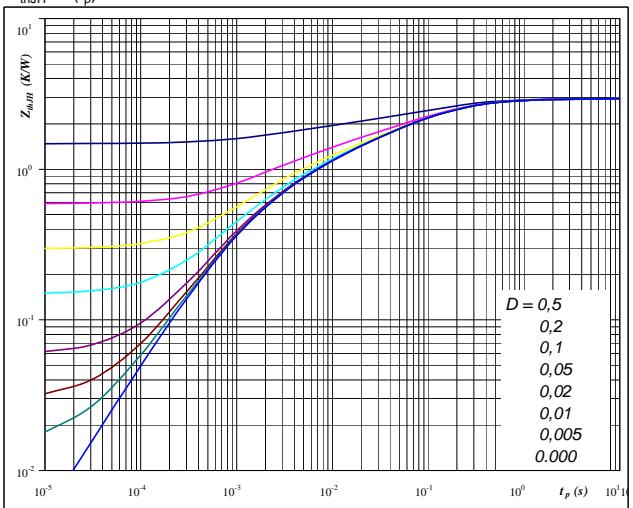
IGBT thermal model values

Thermal grease		Phase change interface	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,07	2,94	0,06	2,38
0,21	0,46	0,17	0,37
0,65	0,12	0,53	0,09
0,31	0,03	0,25	0,02
0,15	0,01	0,12	0,01
0,11	0,00	0,09	0,00

Figure 20
PFC FWD

FWD transient thermal impedance
as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

$D = t_p / T$
 $R_{thJH} = 2,95 \quad K/W$ $R_{thJH} = 2,39 \quad K/W$

FWD thermal model values

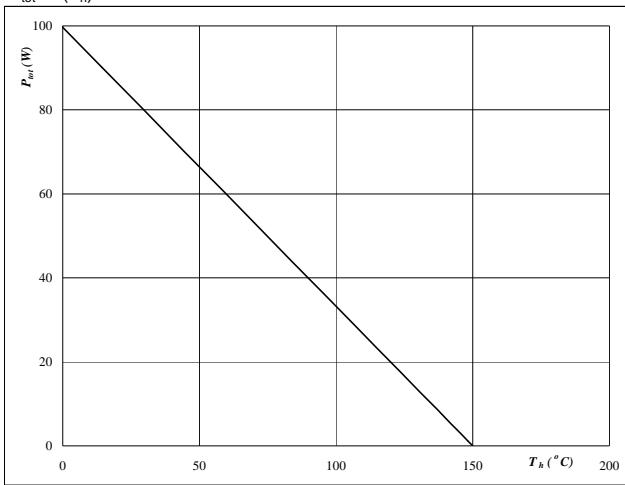
Thermal grease		Phase change interface	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,11	2,95	0,09	2,39
0,51	0,31	0,41	0,26
1,04	0,08	0,84	0,06
0,58	0,01	0,47	0,01
0,45	0,00	0,37	0,00
0,27	0,00	0,22	0,00

PFC

Figure 21

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

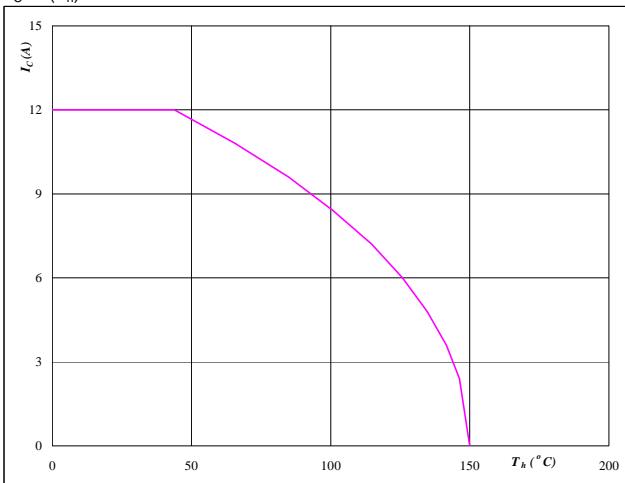

At

$$T_j = 150 \quad ^\circ\text{C}$$

PFC MOSFET
Figure 22

Collector/Drain current as a function of heatsink temperature

$$I_C = f(T_h)$$


At

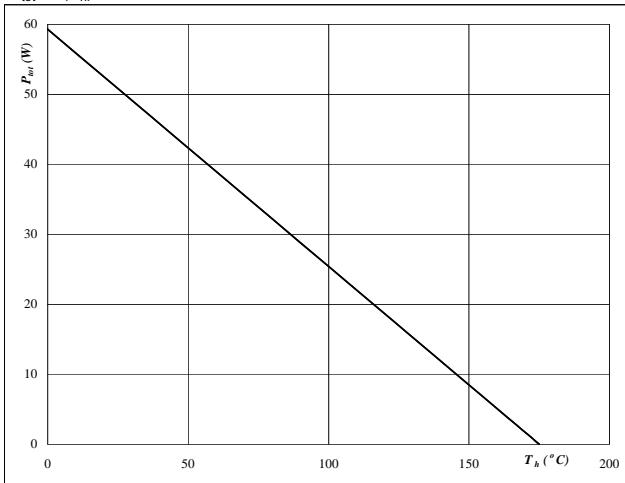
$$T_j = 150 \quad ^\circ\text{C}$$

$$V_{GS} = 10 \quad \text{V}$$

Figure 23

Power dissipation as a function of heatsink temperature

$$P_{\text{tot}} = f(T_h)$$

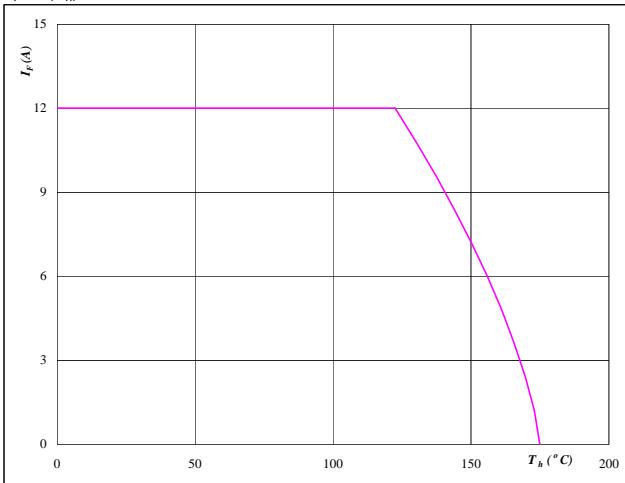

At

$$T_j = 175 \quad ^\circ\text{C}$$

PFC FWD
Figure 24

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

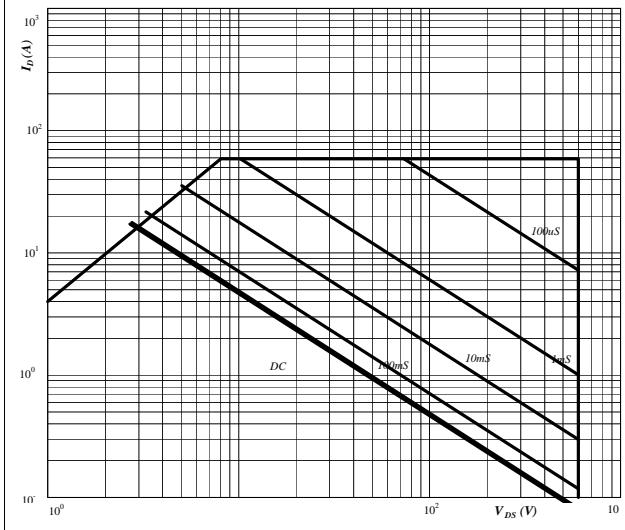

At

$$T_j = 175 \quad ^\circ\text{C}$$

PFC

Figure 25
**Safe operating area as a function
of drain-source voltage**

$$I_D = f(V_{DS})$$



At

D = single pulse

T_h = 80 °C

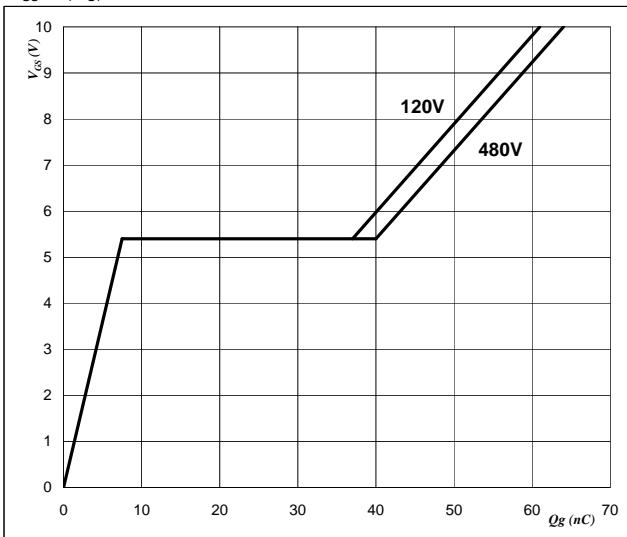
V_{GS} = 10 V

T_j = T_{jmax} °C

PFC MOSFET

Figure 26
Gate voltage vs Gate charge

$$V_{GS} = f(Qg)$$

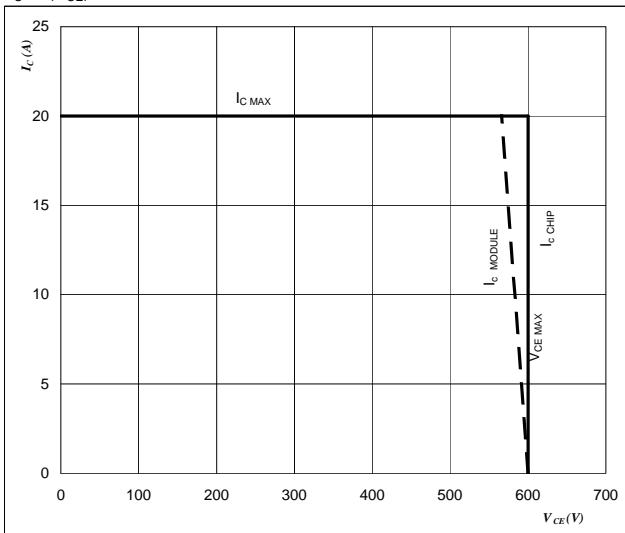


At

I_D = 6 A

Figure 29
Reverse bias safe operating area

$$I_C = f(V_{CE})$$



At

T_j = T_{jmax}-25 °C

U_{ccminus}=U_{ccplus}

Switching mode : 3phase SPWM

IGBT

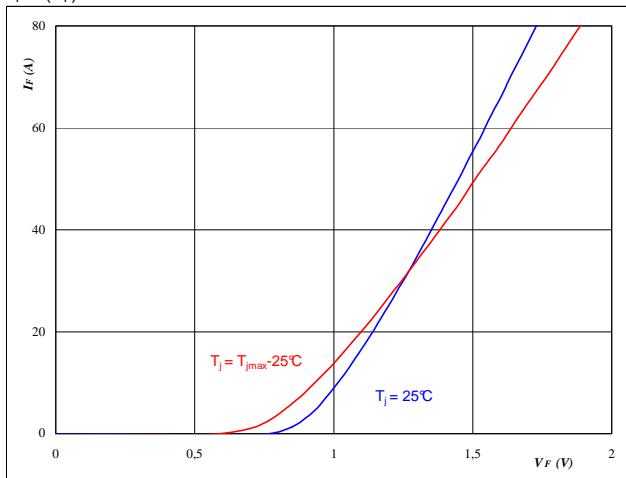
Input Rectifier Bridge

Figure 1

Rectifier diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$


At

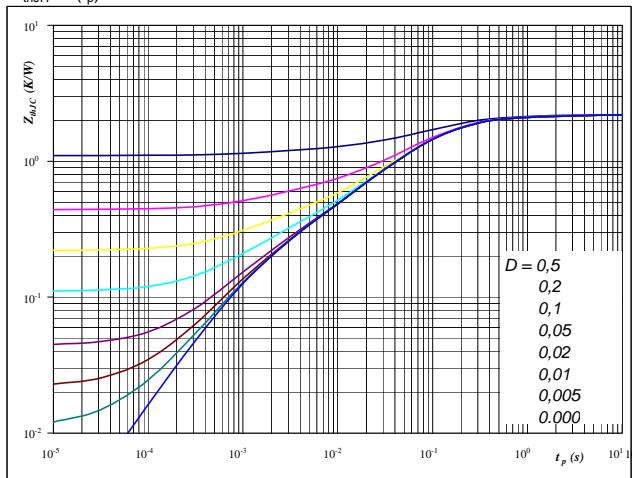
$$t_p = 250 \mu\text{s}$$

Figure 2

Rectifier diode

Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


At

$$D = t_p / T$$

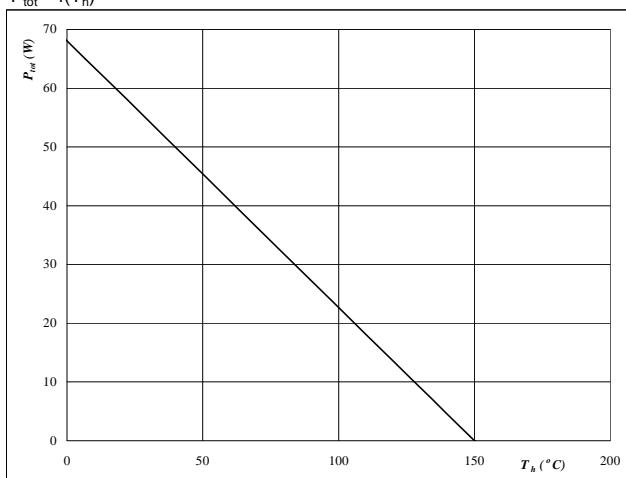
$$R_{thJH} = 2.20 \text{ K/W}$$

Figure 3

Rectifier diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


At

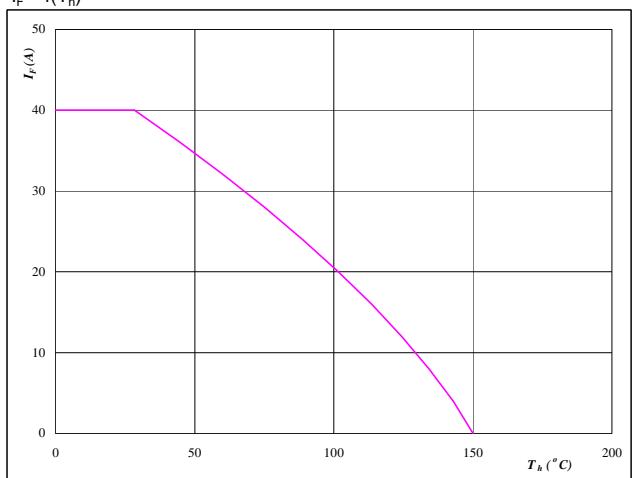
$$T_j = 150^\circ\text{C}$$

Figure 4

Rectifier diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

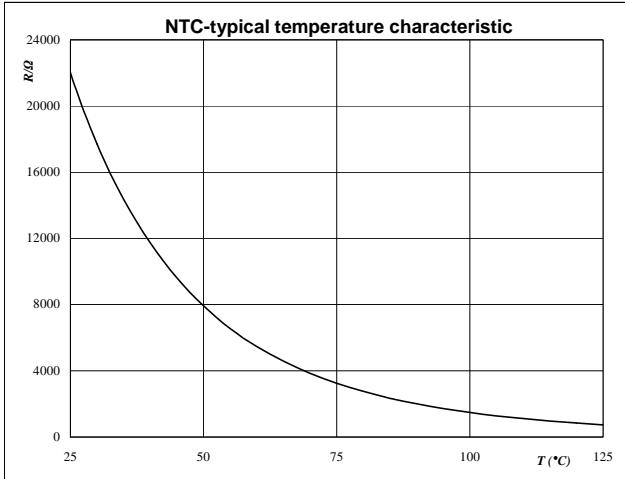

At

$$T_j = 150^\circ\text{C}$$

Thermistor

Figure 1

Typical NTC characteristic
as a function of temperature
 $R_T = f(T)$


Thermistor
Figure 2

Typical NTC resistance values

$$R(T) = R_{25} \cdot e^{\left(B_{25/100} \left(\frac{1}{T} - \frac{1}{T_{25}} \right) \right)} \quad [\Omega]$$

T [°C]	R _{nom} [Ω]	R _{min} [Ω]	R _{max} [Ω]	△R/R [±%]
-55	2089434,5	1506495,4	2672373,6	27,9
0	71804,2	59724,4	83884	16,8
10	43780,4	37094,4	50466,5	15,3
20	27484,6	23684,6	31284,7	13,8
25	22000	19109,3	24890,7	13,1
30	17723,3	15512,2	19934,4	12,5
60	5467,9	4980,6	5955,1	8,9
70	3848,6	3546	4151,1	7,9
80	2757,7	2568,2	2947,1	6,9
90	2008,9	1889,7	2128,2	5,9
100	1486,1	1411,8	1560,4	5
150	400,2	364,8	435,7	8,8

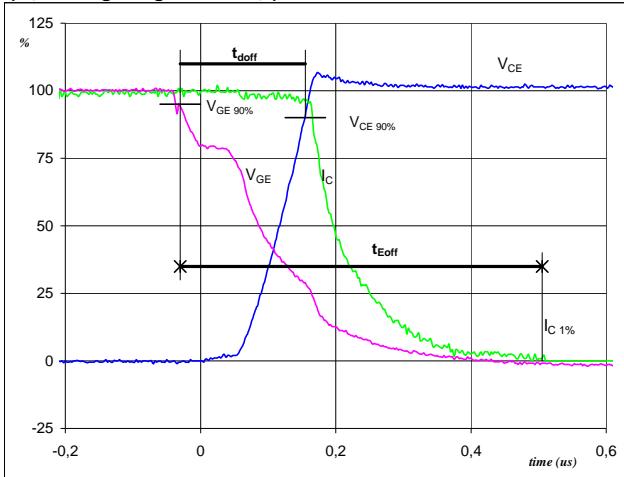
Switching Definitions Output Inverter

General conditions

T_j	=	125 °C
R_{gon}	=	64 Ω
R_{goff}	=	64 Ω

Figure 1

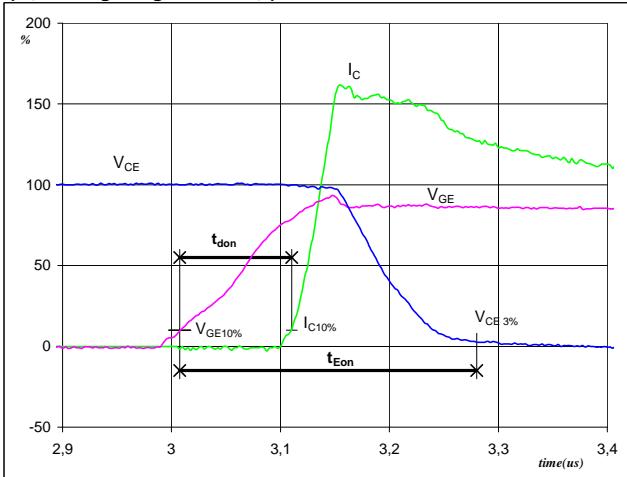
Output inverter IGBT
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})



$V_{GE\ (0\%)} = -15$ V
 $V_{GE\ (100\%)} = 15$ V
 $V_C\ (100\%) = 400$ V
 $I_C\ (100\%) = 6$ A
 $t_{doff} = 0,18$ μs
 $t_{Eoff} = 0,54$ μs

Figure 2

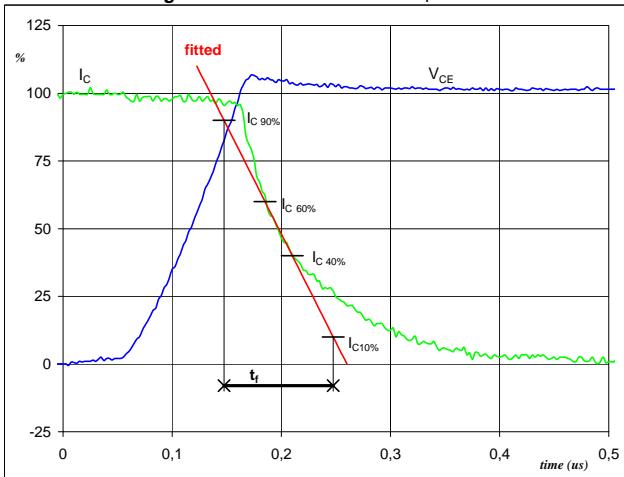
Output inverter IGBT
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})



$V_{GE\ (0\%)} = -15$ V
 $V_{GE\ (100\%)} = 15$ V
 $V_C\ (100\%) = 400$ V
 $I_C\ (100\%) = 6$ A
 $t_{don} = 0,10$ μs
 $t_{Eon} = 0,27$ μs

Figure 3

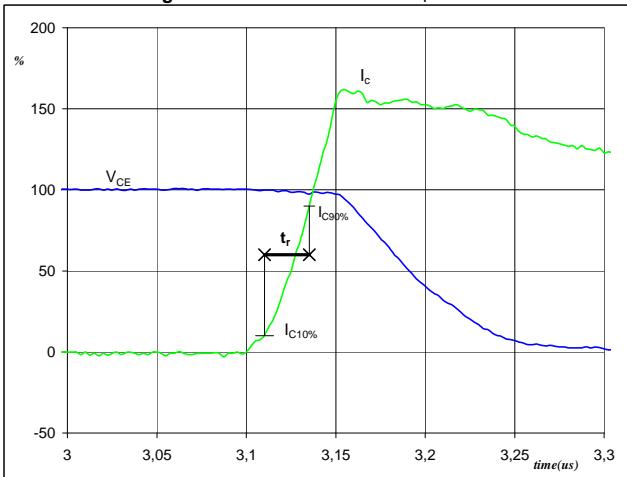
Output inverter IGBT
Turn-off Switching Waveforms & definition of t_f



$V_C\ (100\%) = 400$ V
 $I_C\ (100\%) = 6$ A
 $t_f = 0,11$ μs

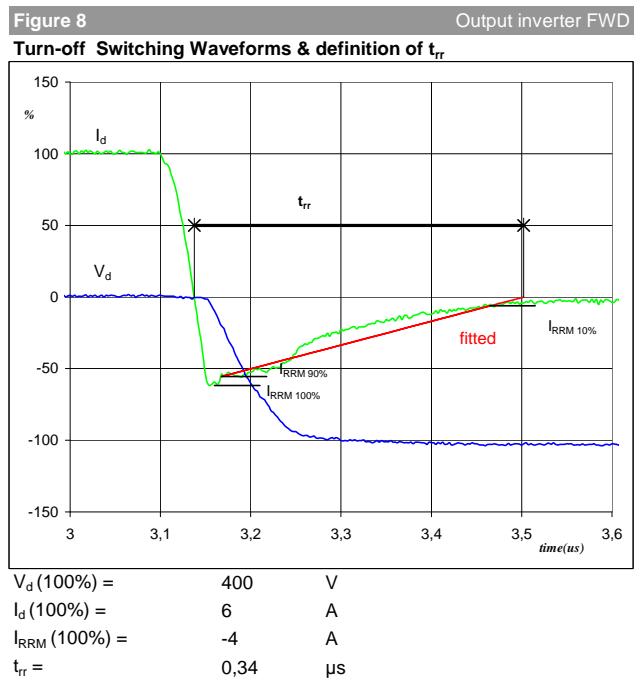
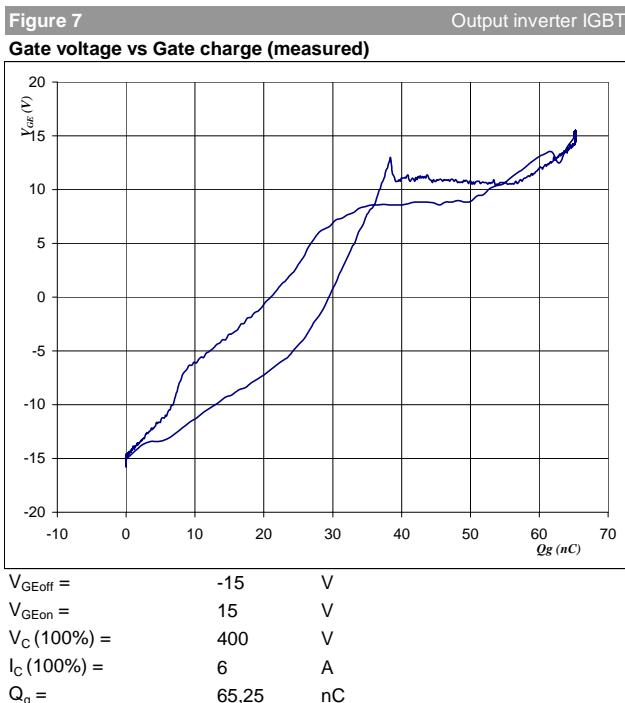
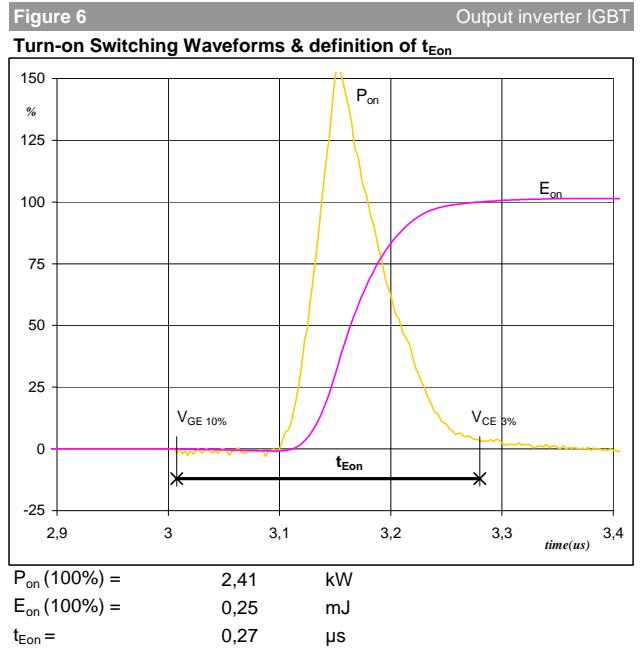
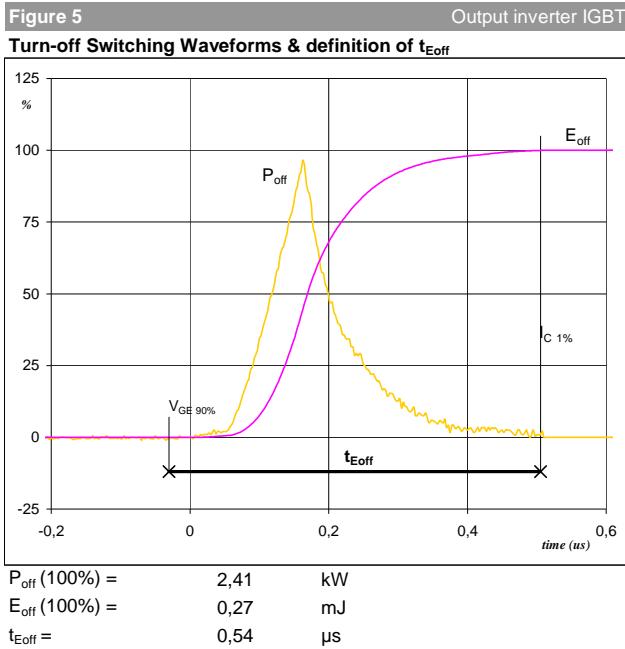
Figure 4

Output inverter IGBT
Turn-on Switching Waveforms & definition of t_r



$V_C\ (100\%) = 400$ V
 $I_C\ (100\%) = 6$ A
 $t_r = 0,03$ μs

Switching Definitions Output Inverter

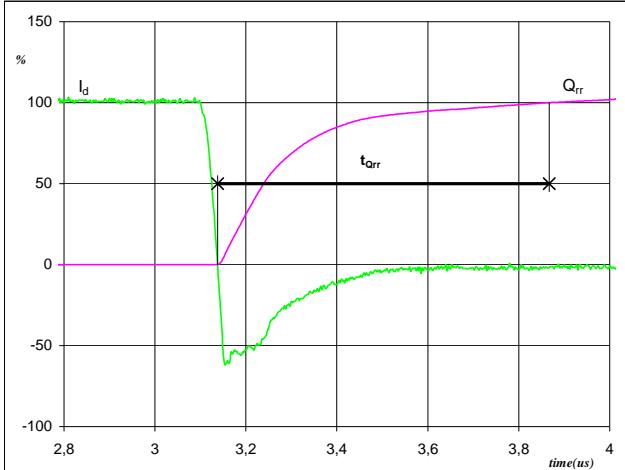


Switching Definitions Output Inverter

Figure 9

Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})

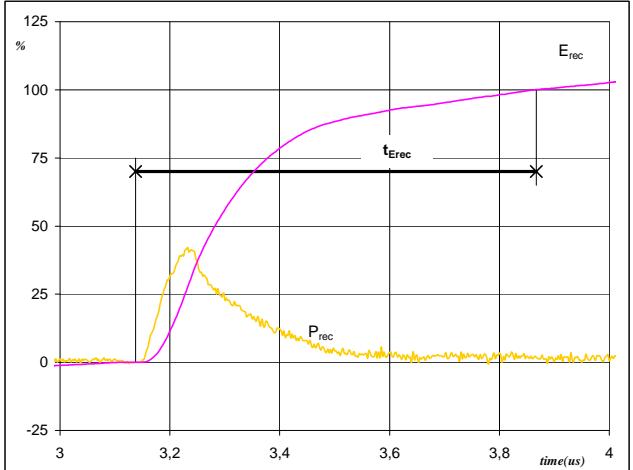


$I_d(100\%) = 6 \text{ A}$
 $Q_{rr}(100\%) = 0,60 \mu\text{C}$
 $t_{Qrr} = 0,73 \mu\text{s}$

Figure 10

Output inverter FWD

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})



$P_{rec}(100\%) = 2,41 \text{ kW}$
 $E_{rec}(100\%) = 0,17 \text{ mJ}$
 $t_{Erec} = 0,73 \mu\text{s}$

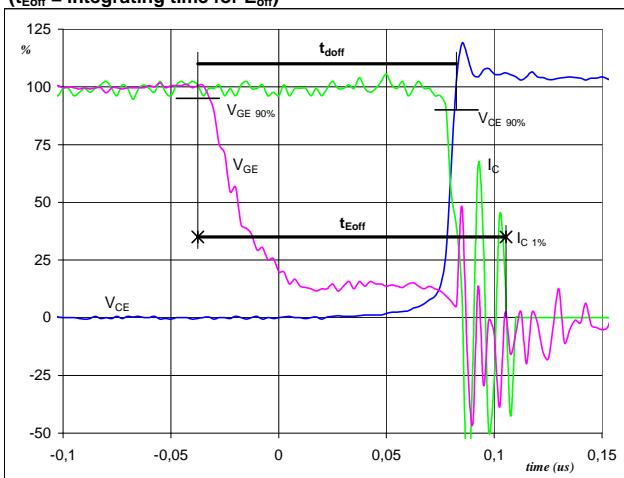
Switching Definitions PFC

General conditions

T_j	= 125 °C
R_{gon}	= 4 Ω
R_{goff}	= 4 Ω

Figure 1

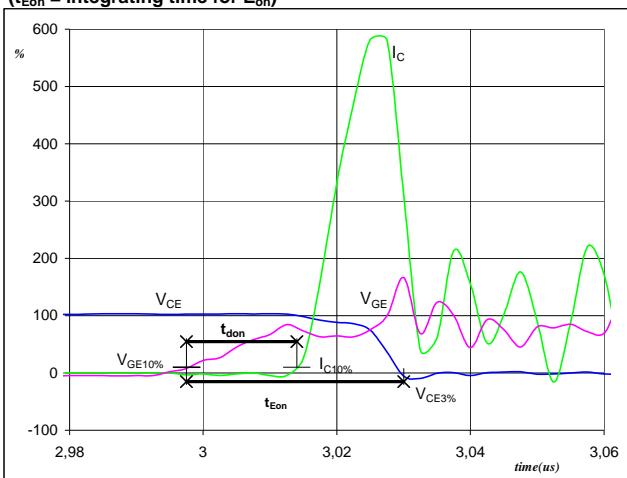
PFC MOSFET
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%) = 0 \text{ V}$
 $V_{GE}(100\%) = 10 \text{ V}$
 $V_C(100\%) = 400 \text{ V}$
 $I_C(100\%) = 6 \text{ A}$
 $t_{doff} = 0,11 \mu\text{s}$
 $t_{Eoff} = 0,14 \mu\text{s}$

Figure 2

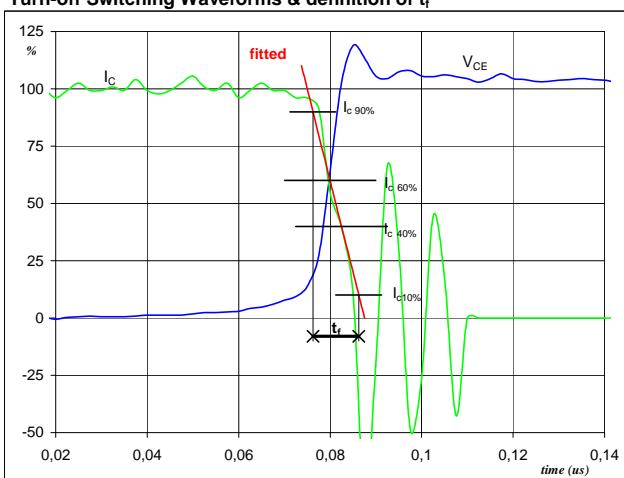
PFC MOSFET
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%) = 0 \text{ V}$
 $V_{GE}(100\%) = 10 \text{ V}$
 $V_C(100\%) = 400 \text{ V}$
 $I_C(100\%) = 6 \text{ A}$
 $t_{don} = 0,02 \mu\text{s}$
 $t_{Eon} = 0,03 \mu\text{s}$

Figure 3

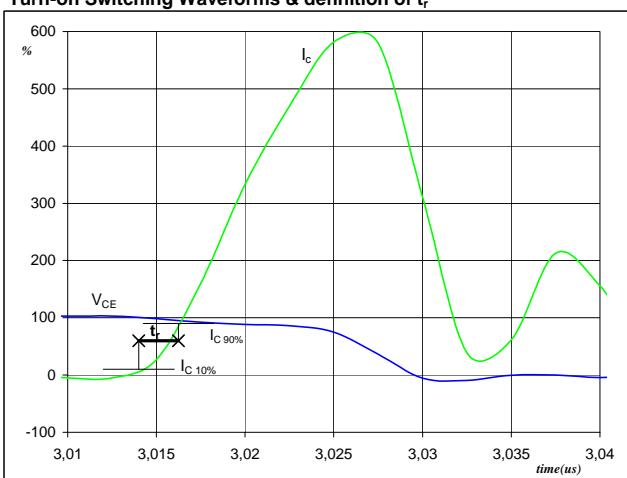
PFC MOSFET
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) = 400 \text{ V}$
 $I_C(100\%) = 6 \text{ A}$
 $t_f = 0,01 \mu\text{s}$

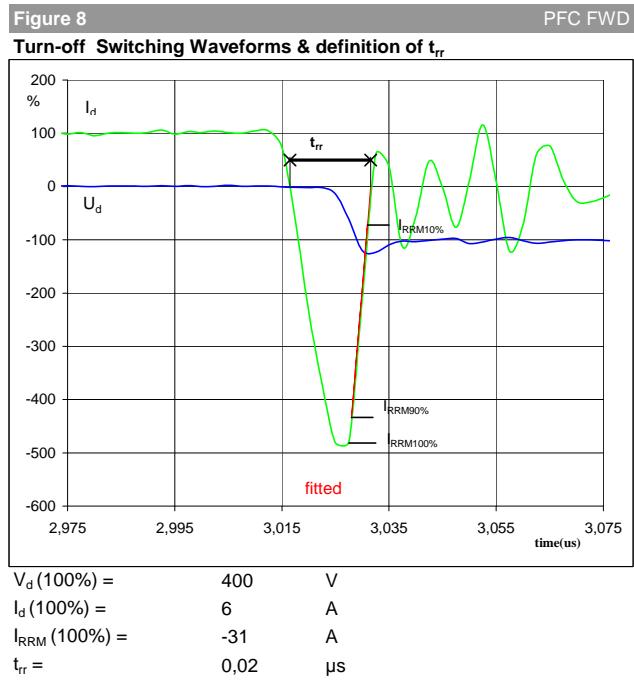
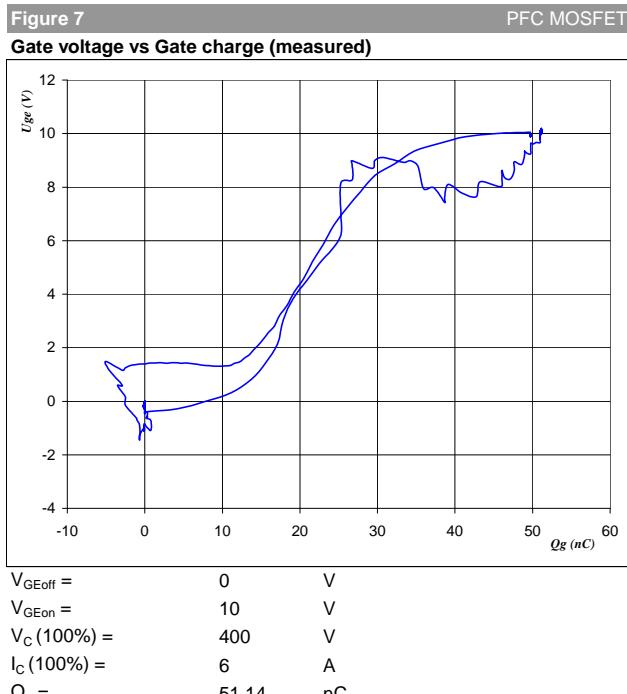
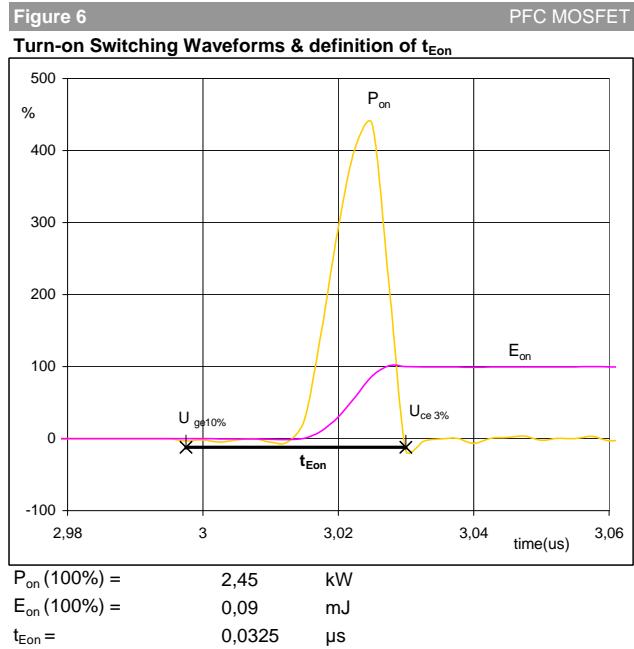
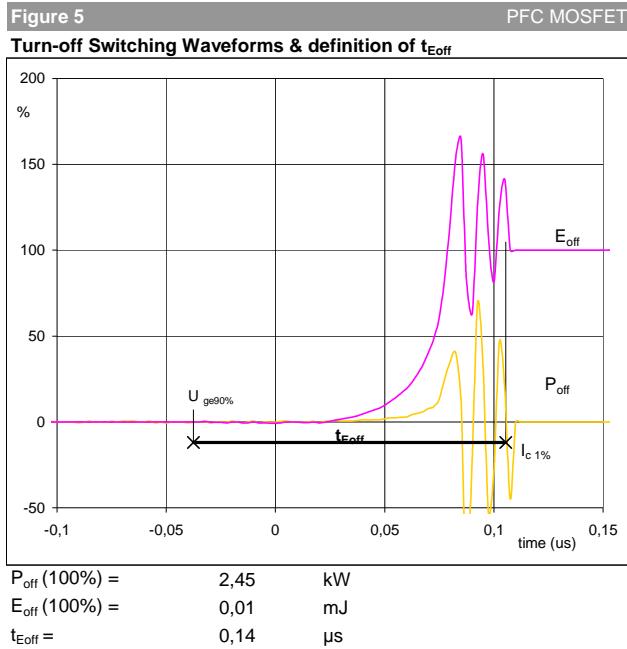
Figure 4

PFC MOSFET
Turn-on Switching Waveforms & definition of t_r



$V_C(100\%) = 400 \text{ V}$
 $I_C(100\%) = 6 \text{ A}$
 $t_r = 0,002 \mu\text{s}$

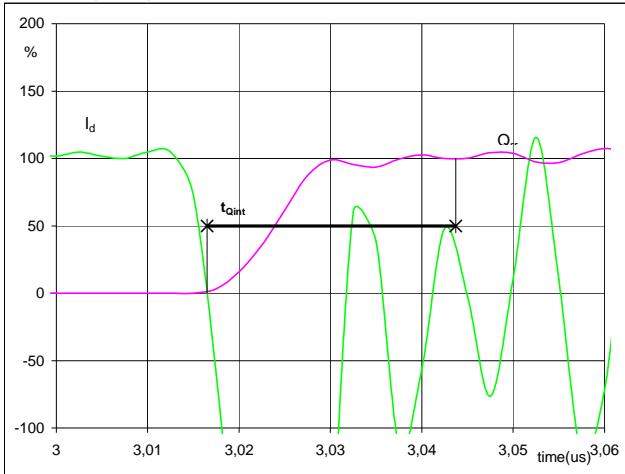
Switching Definitions PFC



Switching Definitions PFC

Figure 9

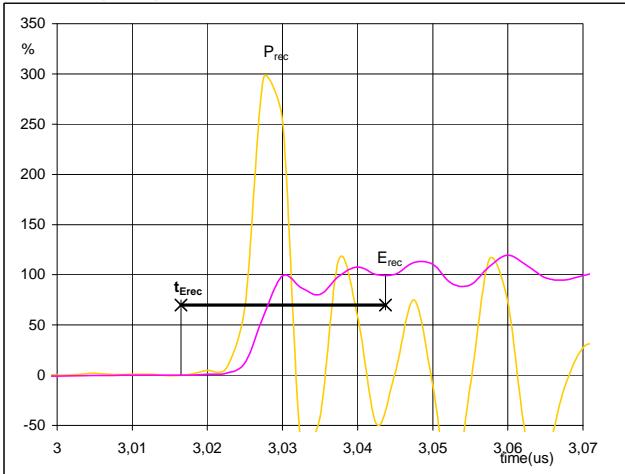
Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})



$$\begin{aligned} I_d(100\%) &= 6 \quad A \\ Q_{rr}(100\%) &= 0,29 \quad \mu C \\ t_{Qint} &= 0,03 \quad \mu s \end{aligned}$$

PFC FWD
Figure 10

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})



$$\begin{aligned} P_{rec}(100\%) &= 2,45 \quad kW \\ E_{rec}(100\%) &= 0,04 \quad mJ \\ t_{Erec} &= 0,03 \quad \mu s \end{aligned}$$

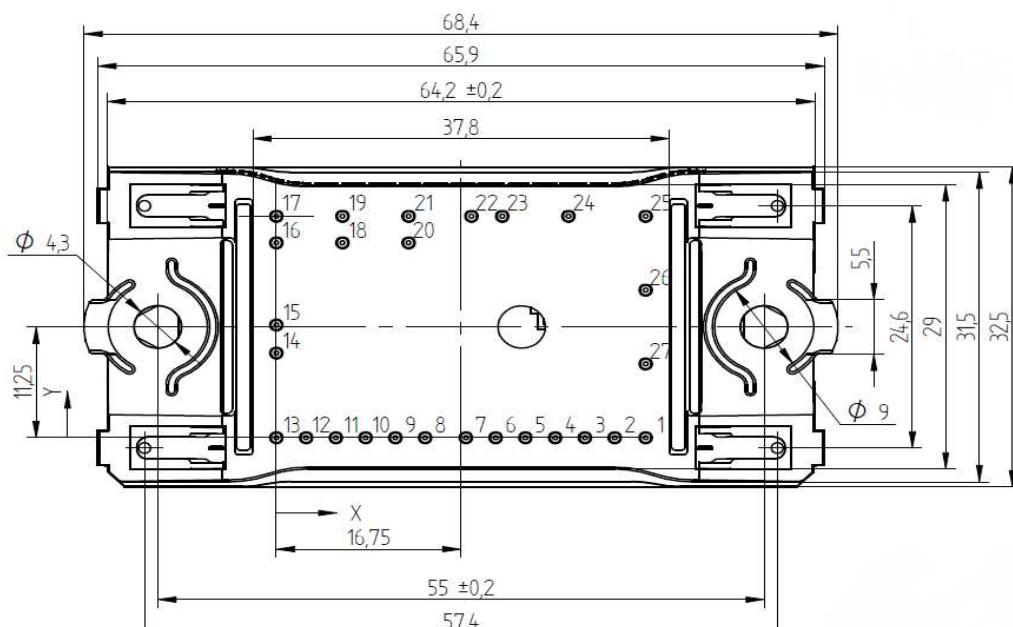
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

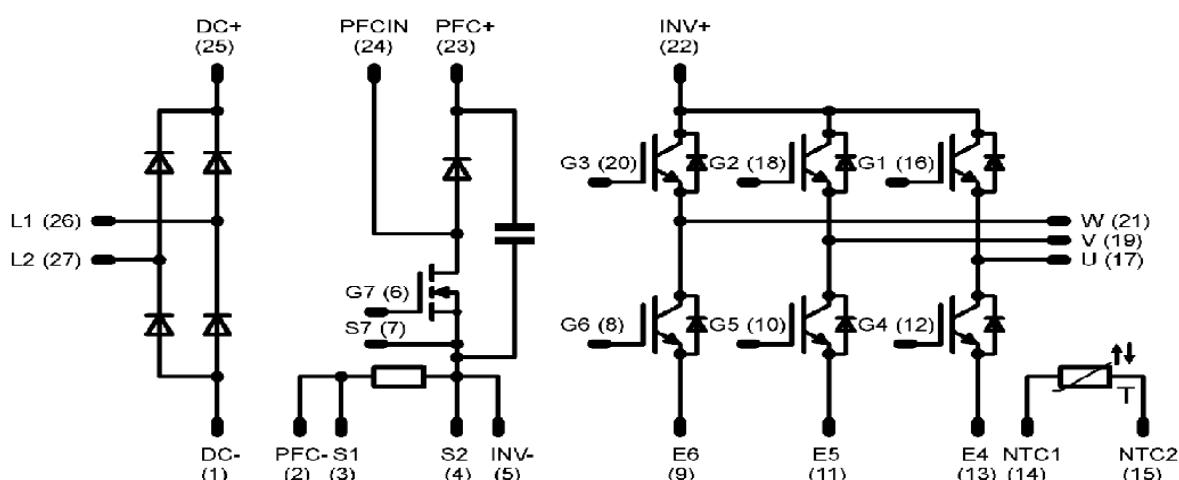
Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 17mm housing	10-F006PPA006SB-M682B	M682B	M682-B

Outline

Pin table		
Pin	X	Y
1	335	0
2	307	0
3	28	0
4	25,3	0
5	22,6	0
6	19,9	0
7	17,2	0
8	13,5	0
9	10,8	0
10	8,1	0
11	5,4	0
12	2,7	0
13	0	0
14	0	8,6
15	0	11,45
16	0	19,8
17	0	22,5
18	6	19,8
19	6	22,5
20	12	19,8
21	12	22,5
22	17,7	22,5
23	20,5	22,5
24	26,5	22,5
25	33,5	22,5
26	33,5	15
27	33,5	7,5



Pinout



PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data may be published at a later date. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.
Final	Full Production	This datasheet contains final specifications. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.

DISCLAIMER

The information given in this datasheet describes the type of component and does not represent assured characteristics. For tested values please contact Vincotech. Vincotech reserves the right to make changes without further notice to any products herein to improve reliability, function or design. Vincotech does not assume any liability arising out of the application or use of any product or circuit described herein; neither does it convey any license under its patent rights, nor the rights of others.

LIFE SUPPORT POLICY

Vincotech products are not authorised for use as critical components in life support devices or systems without the express written approval of Vincotech.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in labelling can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.